

LPC802

32-bit ARM Cortex-M0+ microcontroller; up to 16 KB flash and 2 KB SRAM; 12-bit ADC; Comparator;

Rev. 1.8 — 25 September 2019

Product data sheet

1. General description

The LPC802 is an ARM Cortex-M0+ based, low-cost 32-bit MCU family of processors operating at CPU frequencies of up to 15 MHz. The LPC802 supports 16 KB of flash memory and 2 KB of SRAM.

The peripheral complement of the LPC802 includes one I²C-bus interface, up to two USARTs, one SPI interface, one multi-rate timer, self-wake-up timer, one general purpose 32-bit counter/timer, one 12-bit ADC, one analog comparator, function-configurable I/O ports through a switch matrix, and up to 17 general-purpose I/O pins.

For additional documentation related to the LPC802 parts, see Section 19 "References".

2. Features and benefits

System:

- ◆ ARM Cortex-M0+ processor (revision r0p1), running at frequencies of up to 15 MHz with single-cycle multiplier and fast single-cycle I/O port.
- ◆ ARM Cortex-M0+ built-in Nested Vectored Interrupt Controller (NVIC).
- System tick timer.
- AHB multilayer matrix.
- Serial Wire Debug (SWD) with four break points and two watch points. JTAG boundary scan (BSDL) supported.

Memory:

- ◆ 16 KB on-chip EEPROM based flash programming memory.
- Code Read Protection (CRP).
- 2 KB SRAM.
- Dual I/O power (LPC802M011JDH20):
 - ◆ Independent supplies on each package side permitting level-shifting signals from one off-chip voltage domain to another and/or interfacing directly to off-chip peripherals operating at different supply levels.
 - The switch matrix provides level shifter functionality to allow up to two selected signals to be routed from user-selected pins in one voltage domain to selected pins in the alternate domain. This feature can also be used on a single supply device if voltage level shifting is not required.

ROM API support:

- ◆ Boot loader.
- Supports Flash In-Application Programming (IAP).
- Supports In-System Programming (ISP) through USART.



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- On-chip ROM APIs for integer divide.
- ◆ Free Running Oscillator (FRO) API.
- Digital peripherals:
 - High-speed GPIO interface connected to the ARM Cortex-M0+ I/O bus with up to 17 General-Purpose I/O (GPIO) pins with configurable pull-up/pull-down resistors, programmable open-drain mode, and input inverter. GPIO direction control supports independent set/clear/toggle of individual bits.
 - ◆ High-current source output driver (20 mA) on three pins.
 - ◆ Switch matrix for flexible configuration of each I/O pin function.
 - CRC engine.

■ Timers:

- One 32-bit general purpose counter/timer, with four match outputs and three capture inputs. Supports PWM mode, and external count.
- Two channel Multi-Rate Timer (MRT) for repetitive interrupt generation at up to four programmable, fixed rates.
- Self-Wake-up Timer (WKT) clocked from either Free Running Oscillator (FRO), a low-power, low-frequency internal oscillator, or an external clock input.
- Windowed Watchdog timer (WWDT).
- Analog peripherals:
 - One 12-bit ADC with up to 12 input channels with multiple internal and external trigger inputs and with sample rates of up to 480 Ksamples/s. The ADC supports two independent conversion sequences.
 - ◆ Comparator with four input pins and external or internal reference voltage.
- Serial peripherals:
 - Two USART interfaces with pin functions assigned through the switch matrix and one fractional baud rate generators.
 - ◆ One SPI controller with pin functions assigned through the switch matrix.
 - ◆ One I²C-bus interface. Supports Standard mode and Fast mode.
- Clock generation:
 - ◆ Free Running Oscillator (FRO). This oscillator provides selectable 9 MHz, 12 MHz and 15 MHz outputs that can be used as a system clock. The FRO is trimmed to ±1 % accuracy over the entire voltage and temperature range of 0 C to 70 C.
 - ◆ 1 MHz low power oscillator can be used as a clock source.
 - Clock output function with divider that can reflect all internal clock sources.
- Power control:
 - Reduced power modes: sleep mode, deep-sleep mode, power-down mode, and deep power-down mode.
 - ◆ Wake-up from deep-sleep and power-down modes on activity on USART, SPI, and I²C peripherals.
 - Wake-up from deep power-down mode on multiple pins.
 - ◆ Timer-controlled self wake-up from sleep, deep-sleep, and power-down modes.
 - Power-On Reset (POR).
 - Brownout detect (BOD).

- Unique device serial number for identification.
- Single or dual power supplies (1.71 V to 3.6 V).
- Operating temperature range -40 °C to +105 °C.
- Available in WLCSP16, TSSOP16, TSSOP20, and HVQFN33 packages.

3. Applications

- Sensor gateways
- Industrial
- Gaming controllers
- 8/16-bit applications
- Consumer
- Climate control

- Simple motor control
- Portables and wearables
- Lighting
- Motor control
- Fire and security applications

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4. Ordering information

Table 1. Ordering information

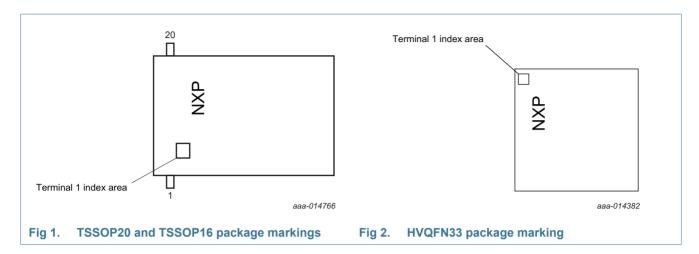
Type number	Package							
	Name	Description	Version					
LPC802M001JDH16	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1					
LPC802M001JDH20	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1					
LPC802M011JDH20	TSSOP20	plastic thin shrink small outline package; 20 leads; body width 4.4 mm	SOT360-1					
LPC802M001JHI33	HVQFN33	HVQFN: plastic thermal enhanced very thin quad flat package; no leads; 33 terminals; body 5 \times 5 \times 0.85 mm	n/a					
LPC802UK	WLCSP16	wafer level chip-size package; 16 (4 \times 4) bumps; 1.86 \times 1.86 \times 0.3 mm	SOT1393-2					

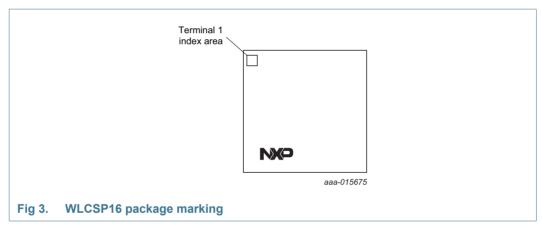
4.1 Ordering options

Table 2. Ordering options

Type number	Flash/KB	SRAM/ KB	USART	1 ² C	SPI	GPIO	Dual I/O power supply	Package
LPC802M001JDH16	16	2	2	1	1	13	-	TSSOP16
LPC802M001JDH20	16	2	2	1	1	17	-	TSSOP20
LPC802M011JDH20	16	2	2	1	1	16	yes	TSSOP20
LPC802M001JHI33	16	2	2	1	1	17	-	HVQFN33
LPC802UK	16	2	2	1	1	13	-	WLCSP16

5. Marking





The LPC802 HVQFN33 packages have the following top-side marking:

First line: LPC802M0Second line: xxxx

• Third line: yywwx[R]

yyww: Date code with yy = year and ww = week.

- xR = Boot code version and device revision.

The LPC802 TSSOP20 packages typically have the following top-side marking:

First line: LPC802Second line: M0y1

y: 0 or 1Third line: xxxx

Fourth line: xxywwx[R]

- yww: Date code with y = year and ww = week.

- xR = Boot code version and device revision.

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The LPC802 TSSOP16 packages have the following top-side marking:

First line: LPC802Second line: M001JThird line: xxxx

• Fourth line: ywwx[R]

yww: Date code with y = year and ww = week.
xR = Boot code version and device revision.

The LPC802 WLCSP16 packages have the following top-side marking:

First line: LPC802Second line: xxxxxThird line: xyywwx[R]

- yyww: Date code with ww = week and yy = year.

- xR = Boot code version and device revision.

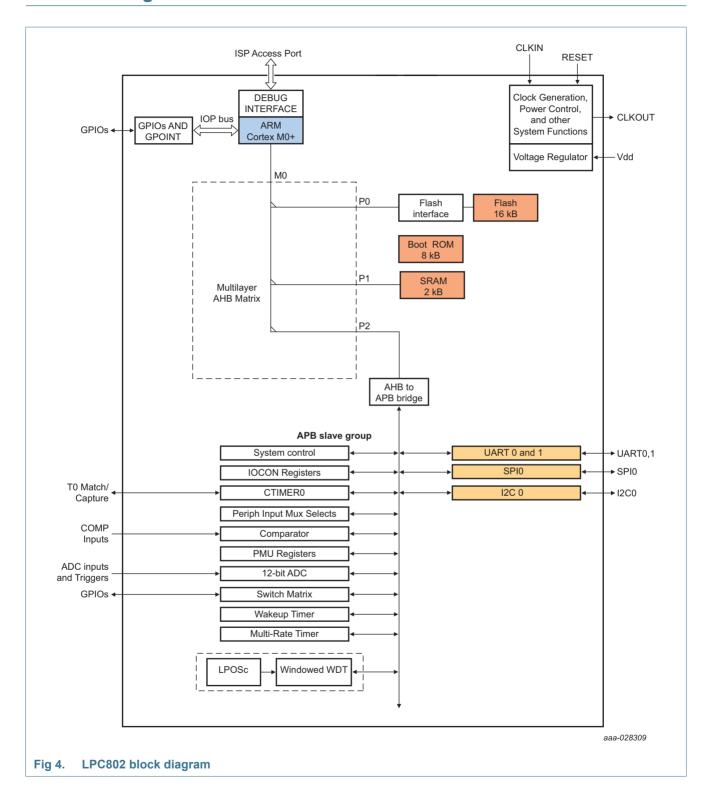
• Fourth line: xxx - yyy

Table 3. Device revision table

Revision identifier (R)	Revision description
0A	Initial device revision with Boot ROM version 13.0
1A	Second device revision with Boot ROM version 13.1
1B	Third device revision with Boot ROM version 13.1
1C (TSSOP16 only)	Fourth device revision with Boot ROM version 13.1
1D	Fifth device revision with Boot ROM version 13.1

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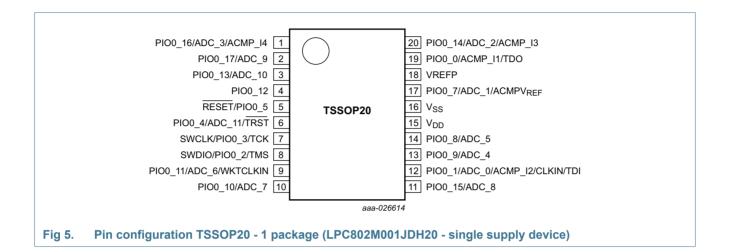
6. Block diagram

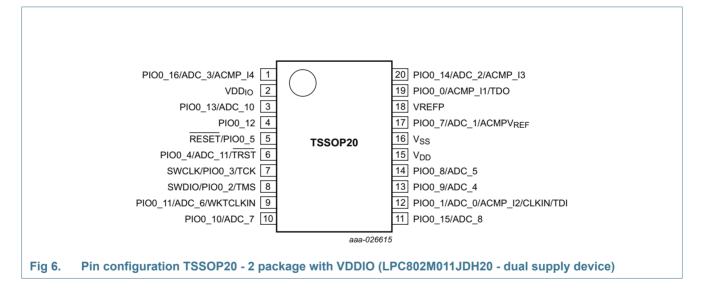


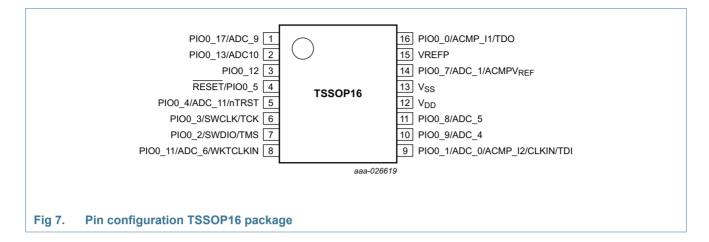
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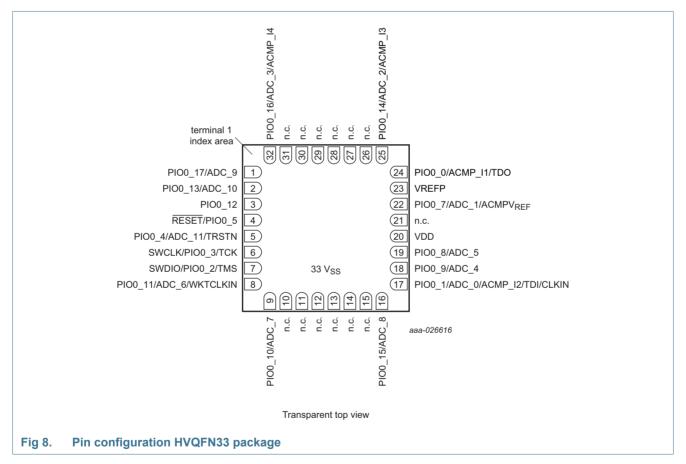
7. Pinning information

7.1 Pinning









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7.2 Pin description

<u>Table 4</u> shows the pin functions that are fixed to specific pins on each package. These fixed-pin functions are selectable through the switch matrix between GPIO and the comparator, ADC, SWD, and <u>RESET</u> pins. By default, the GPIO function is selected except on pins PIO0_2, PIO0_3, and PIO0_5. JTAG functions are available in boundary scan mode only.

Movable functions for the I2C, USART, SPI, CTimer pins and other peripherals can be assigned through the switch matrix to any pin that is not power or ground in place of the pin's fixed functions.

The following exceptions apply:

Do not assign more than one output to any pin. However, an output and/or one or more inputs can be assigned to a pin. Once any function is assigned to a pin, the pin's GPIO functionality is disabled.

Eight GPIO pins trigger a wake-up from deep power-down mode. If the part must wake up from deep power-down mode via an external pin, do not assign any movable function to this pin. The GPIO pins should be pulled HIGH externally before entering deep power-down mode. A LOW-going pulse as short as 50 ns causes the chip to exit deep power-down mode and wakes up the part.

The JTAG functions TDO, TDI, TCK, TMS, and TRST are selected on pins PIO0_0 to PIO0_4 by hardware when the part is in boundary scan mode.

PIO0_2, PIO0_3, and PIO0_12 are the high drive output pins. PIO0_4, PIO0_8, PIO0_9, PIO0_10, PIO0_11, PIO0_13, PIO0_15, and PIO0_17 are the WAKEUP pins.

Table 4. Pin description

Symbol	TSSOP20-1	TSSOP20-2	TSSOP16	HVQFN33	WLCSP16		Reset state[1]	Type	Description
PIO0_0/ ACMP_I1/TDO	19	19	16	24	D3	[2]	I; PU	Ю	PIO0_0 — General-purpose port 0 input/output 0. In ISP mode, this is the U0_RXD pin (for single supply devices). In boundary scan mode: TDO (Test Data Out).
PIO0_1/ADC_0/ ACMP_I2/CLKIN/TDI/	12	12	9	17	A4	[2]	I; PU	A IO	ACMP_I1 — Analog comparator input 1. PIO0_1 — General-purpose port 0 input/output 1. In boundary scan mode: TDI (Test Data In).
								A I	ACMP_I2 — Analog comparator input 2. CLKIN — External clock input.
SWDIO/PIO0_2/ TMS	8	8	7	7	A2	[3]	I; PU	Ю	SWDIO — Serial Wire Debug I/O. SWDIO is enabled by default on this pin. In boundary scan mode: TMS (Test Mode Select).
								I/O	PIO0_2 — General-purpose port 0 input/output 2.
SWCLK/PIO0_3/ TCK	7	7	6	6	B1	[3]	I; PU	I	SWCLK — Serial Wire Clock. SWCLK is enabled by default on this pin. In boundary scan mode: TCK (Test Clock).
								Ю	PIO0_3 — General-purpose port 0 input/output 3.
PIO0_4/ADC_11/ TRSTN	6	6	5	5	B2	[2]	I; PU	IO A	PIO0_4 — General-purpose port 0 input/output 4. In ISP mode, this pin is the U0_TXD pin (for single supply devices). In boundary scan mode: TRST (Test Reset). ADC_11 — ADC input 11.
RESET/PIO0_5	5	5	4	4	C2	[4][5]	I; PU	Ю	RESET — External reset input: A LOW-going pulse as short as 50 ns on this pin resets the device, causing I/O ports and peripherals to take on their default states, and processor execution to begin at address 0. The RESET pin can be left unconnected or be used as a GPIO or for any movable function if an external RESET function is not needed.
								I	PIO0_5 — General-purpose port 0 input/output 5.
PIO0_7/ADC_1/ ACMPV _{REF}	17	17	14	22	C3	[2]	I; PU	Ю	PIO0_7 — General-purpose port 0 input/output 7.
								A	ADC_1 — ADC input 1. ACMPV _{REF} — Alternate reference voltage for the analog comparator.

Table 4. Pin description

Symbol	TSSOP20-1	TSSOP20-2	TSSOP16	HVQFN33	WLCSP16		Reset state[1]	Type	Description
PIO0_8/ADC_5	14	14	11	19	В3	[2]	I; PU	Ю	PIO0_8 — General-purpose port 0 input/output 8. In ISP mode, this is the U0_RXD pin (for dual supply devices).
								Α	ADC_5 — ADC input 5.
PIO0_9/ADC_4	13	13	10	18	A3	[2]	I; PU	Ю	PIO0_9 — General-purpose port 0 input/output 9. In ISP mode, this is the U0_TXD pin (for dual supply devices)
								Α	ADC_4 — ADC input 4.
PIO0_10/ADC_7	10	10	-	9	-	[2]	I; PU	Ю	PIO0_10 — General-purpose port 0 input/output 10.
								Α	ADC_7 — ADC input 7.
PIO0_11/ADC_6/ WKTCLKIN	9	9	8	8	A1	[6]	I; PU	Ю	PIO0_11 — General-purpose port 0 input/output 11.
								Α	ADC_6 — ADC input 6.
								I	WKTCKLKIN — This pin can host an external clock for the self-wake-up timer. To use the pin as a self-wake-up timer clock input, select the external clock in the wake-up timer CTRL register. The external clock input is active in sleep, deep-sleep, and power-down modes.
PIO0_12	4	4	3	3	C1	[3]	I; PU	IO	PIO0_12 — General-purpose port 0 input/output 12. ISP entry pin. A LOW level on this pin during reset starts the ISP command handler.
PIO0_13/ADC_10	3	3	2	2	D2	[2]	I; PU	Ю	PIO0_13 — General-purpose port 0 input/output 13.
								Α	ADC_10 — ADC input 10.
PIO0_14/ ACMP_I3/ADC_2	20	20	-	25	-	[2]	I; PU	Ю	PIO0_14 — General-purpose port 0 input/output 14.
								Α	ACMP_I3 — Analog comparator common input 3.
								Α	ADC_2 — ADC input 2.
PIO0_15/ADC8	11	11	-	16	-	[2]	I; PU	Ю	PIO0_15 — General-purpose port 0 input/output 15.
									ADC_8 — ADC input 8.
PIO0_16/ ACMP_I4/ADC_3	1	1	-	32	-	[2]	I; PU	Ю	PIO0_16 — General-purpose port 0 input/output 16.
									ACMP_I4 — Analog comparator common input 4.
									ADC_3 — ADC input 3.
PIO0_17/ADC_9	2	-	1	1	D1	[2]	I; PU	Ю	PIO0_17 — General-purpose port 0 input/output 17.
								Α	ADC_9 — ADC input 9.

Table 4. Pin description

Symbol	TSSOP20-1	TSSOP20-2	TSSOP16	HVQFN33	WLCSP16	Reset state ^[1]	Туре	Description
V_{DD}	15	15	12	20	B4	-	-	If VDDIO is present, VDD is the supply voltage for the I/Os on the right side of the package and the core voltage regulator. If VDDIO is not present, VDD also supplies voltage to the I/Os on the left side of the package.
VDD _{IO}	-	2	-	-	-	-	-	If present, it is the supply voltage for the I/Os on the left side of the package.
V_{SS}	16	16	13	33[8]	C4	-	-	Ground.
VREFP	18	18	15	23	D4		А	VREFP — ADC positive reference voltage. Must be equal or lower than V _{DD} .
n.c.	-	-	-	10, 11, 12, 13, 14, 15, 21, 26, 27, 28, 29, 30, 31	-	-	-	no connect.

- [1] Pin state at reset for default function: I = Input; AI = Analog Input; O = Output; PU = internal pull-up enabled (pins pulled up to full V_{DD} level); IA = inactive, no pull-up/down enabled; F = floating. For pin states in the different power modes, see Section 15.5 "Pin states in different power modes". For termination on unused pins, see Section 15.4 "Termination of unused pins".
- [2] 5 V tolerant pin providing standard digital I/O functions with configurable modes, configurable hysteresis, and analog input. When configured as an analog input, the digital section of the pin is disabled, and the pin is not 5 V tolerant.
- [3] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis; includes high-current output driver.
- [4] 5 V tolerant pad providing digital I/O functions with configurable pull-up/pull-down resistors and configurable hysteresis.
- [5] See Figure 16 for the reset pad configuration. This pin includes a 20 ns glitch filter (active in all power modes). RESET functionality is not available in deep power-down mode. Use the WAKEUP pins to reset the chip and wake up from deep power-down mode.
- [6] The WKTCLKIN function is enabled in the PINENABLE0 register in the PMU. See the LPC802 user manual.
- [7] The digital part of this pin is 3 V tolerant pin due to special analog functionality. Pin provides standard digital I/O functions with configurable modes, configurable hysteresis, and an analog input. When configured as an analog input, the digital section of the pin is disabled.
- [8] Thermal pad for HVQFN33.

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8. Movable functions

Movable functions for the I2C, USART, SPI, CTimer pins and other peripherals can be assigned through the switch matrix to any pin that is not power or ground in place of the fixed functions of the pin.

Table 5. Movable functions (assign to pins PIO0_0 to PIO0_5, PIO0_7 to PIO0_17 through switch matrix)

Function name	Туре	Description
Ux_TXD	0	Transmitter output for USART0 to USART1.
Ux_RXD	I	Receiver input for USART0 to USART1.
Ux_RTS	0	Request To Send output for USART0.
Ux_CTS	I	Clear To Send input for USART0.
Ux_SCLK	I/O	Serial clock input/output for USART0 to USART1 in synchronous mode.
SPIx_SCK	I/O	Serial clock for SPI0.
SPIx_MOSI	I/O	Master Out Slave In for SPI0.
SPIx_MISO	I/O	Master In Slave Out for SPI0.
SPIx_SSEL0	I/O	Slave select 0 for SPI0.
SPIx_SSEL1	I/O	Slave select 1 for SPI0.
I2Cx_SDA	I/O	I ² C0 bus data input/output.
I2Cx_SCL	I/O	I ² C0 bus clock input/output.
ACMP_O	0	Analog comparator output.
CLKOUT	0	Clock output.
GPIO_INT_BMAT	0	Output of the pattern match engine.
T0_MAT0	0	Timer Match channel 0.
T0_MAT1	0	Timer Match channel 1.
T0_MAT2	0	Timer Match channel 2.
T0_MAT3	0	Timer Match channel 3.
T0_CAP0	I	Timer Capture channel 0.
T0_CAP1	I	Timer Capture channel 1.
T0_CAP2	I	Timer Capture channel 2.
LVLSHFT_IN0	I	Level shift input 0.
LVLSHFT_IN1	I	Level shift input 1.
LVLSHFT_OUT0	0	Level shift output 0.
LVLSHFT_OUT1	0	Level shift output 1.

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9. Functional description

9.1 ARM Cortex-M0+ core

The ARM Cortex-M0+ core runs at an operating frequency of up to 15 MHz using a two-stage pipeline. The core revision is r0p1.

Integrated in the core are the NVIC and Serial Wire Debug with four breakpoints and two watchpoints. The ARM Cortex-M0+ core supports a single-cycle I/O enabled port for fast GPIO access.

The core includes a single-cycle multiplier and a system tick timer.

9.2 On-chip flash program memory

The LPC802 contain up to 16 KB of on-chip EEPROM based flash program memory.

9.3 On-chip SRAM

The LPC802 contain a total of 2 KB on-chip static RAM data memory.

9.4 On-chip ROM

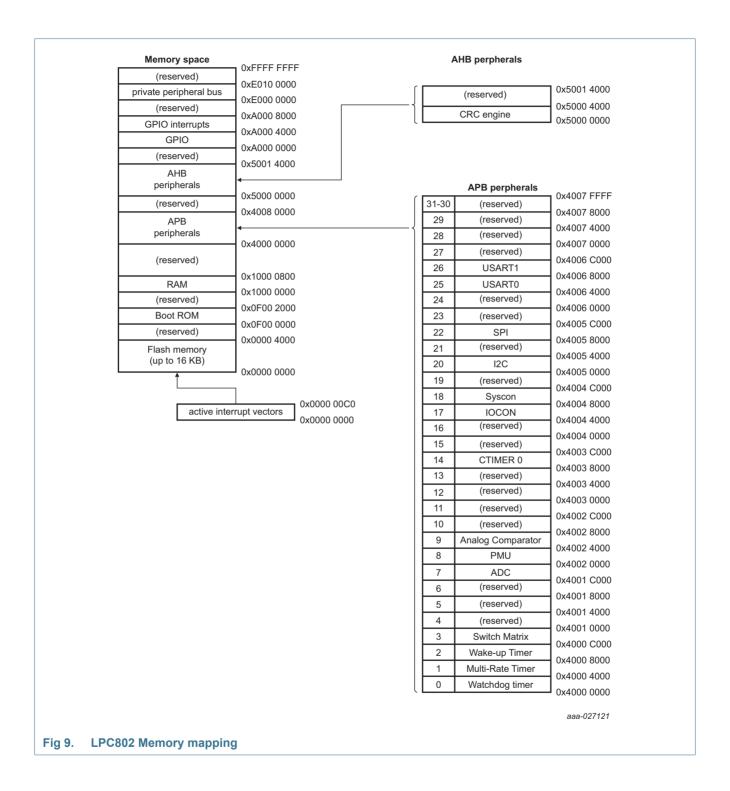
The on-chip ROM contains the bootloader:

- · Boot loader.
- Supports Flash In-Application Programming (IAP).
- Supports In-System Programming (ISP) through USART.
- On-chip ROM APIs for integer divide.
- Free Running Oscillator (FRO) API.

9.5 Memory map

The LPC802 incorporates several distinct memory regions. <u>Figure 9</u> shows the overall map of the entire address space from the user program viewpoint following reset. The interrupt vector area supports address remapping.

The ARM private peripheral bus includes the ARM core registers for controlling the NVIC, the system tick timer (SysTick), and the reduced power modes.



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9.6 Nested Vectored Interrupt Controller (NVIC)

The Nested Vectored Interrupt Controller (NVIC) is part of the Cortex-M0+. The tight coupling to the CPU allows for low interrupt latency and efficient processing of late arriving interrupts.

9.6.1 Features

- Nested Vectored Interrupt Controller is a part of the ARM Cortex-M0+.
- Tightly coupled interrupt controller provides low interrupt latency.
- · Controls system exceptions and peripheral interrupts.
- Supports 32 vectored interrupts.
- In the LPC802, the NVIC supports vectored interrupts for each of the peripherals and the eight pin interrupts.
- Four programmable interrupt priority levels with hardware priority level masking.
- Software interrupt generation using the ARM exceptions SVCall and PendSV.
- · Supports NMI.

9.6.2 Interrupt sources

Each peripheral device has at least one interrupt line connected to the NVIC but can have several interrupt flags. Individual interrupt flags can also represent more than one interrupt source.

9.7 System tick timer

The ARM Cortex-M0+ includes a 24-bit system tick timer (SysTick) that is intended to generate a dedicated SysTick exception at a fixed time interval (typically 10 ms).

9.8 I/O configuration

The IOCON block controls the configuration of the I/O pins. Each digital or mixed digital/analog pin with the PIOO_n designator in Table 4 can be configured as follows:

- Enable or disable the weak internal pull-up and pull-down resistors.
- Select a pseudo open-drain mode. The input cannot be pulled up above V_{DD}. The pins are not 5 V tolerant when V_{DD} is grounded.
- Program the input glitch filter with different filter constants using one of the IOCON divided clock signals (IOCONCLKCDIV, see <u>Figure 12 "LPC802 clock generation"</u>). You can also bypass the glitch filter.
- · Invert the input signal.
- · Hysteresis can be enabled or disabled.
- The switch matrix setting enables the analog input mode on pins with analog and digital functions. Enabling the analog mode disconnects the digital functionality.
- The LPC802 uses a dual voltage I/O feature. The pins on one side of the package are supplied by VDDIO and the pins on the other side are supplied by VDD. Each of these two supplies can be connected to different voltages within the allowed Vdd range. This feature allows the device to level-shift signals from one off-chip voltage domain to another.

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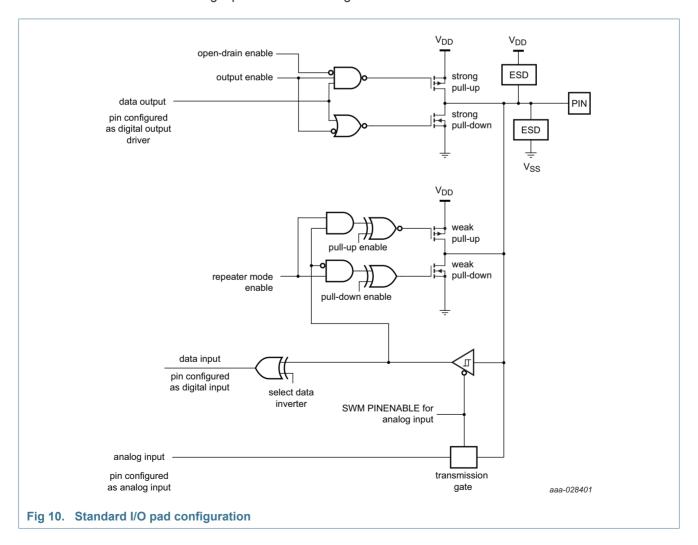
 The switch matrix provides level shifter functionality to allow up to two selected signals to be routed from user-selected pins in one voltage domain to selected pins in the alternate domain. This feature can also be used on a single supply device if voltage level shifting is not required.

Remark: The functionality of each I/O pin is flexible and is determined entirely through the switch matrix. See Section 9.9 for details.

9.8.1 Standard I/O pad configuration

Figure 10 shows the possible pin modes for standard I/O pins with analog input function:

- · Digital output driver with configurable open-drain output.
- Digital input: Weak pull-up resistor (PMOS device) enabled/disabled.
- Digital input: Weak pull-down resistor (NMOS device) enabled/disabled.
- Digital input: Repeater mode enabled/disabled.
- Digital input: Programmable input digital filter selectable on all pins.
- · Analog input: Selected through the switch matrix.



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9.9 Switch Matrix (SWM)

The switch matrix controls the function of each digital or mixed analog/digital pin in a highly flexible way by allowing to connect many functions like the USART, SPI, CTimer, and I2C functions to any pin that is not power or ground. These functions are called movable functions and are listed in Table 5.

Functions that need specialized pads can be enabled or disabled through the switch matrix. These functions are called fixed-pin functions and cannot move to other pins. The fixed-pin functions are listed in <u>Section 7.2 "Pin description"</u>. If a fixed-pin function is disabled, any other movable function can be assigned to this pin.

9.10 Fast General-Purpose parallel I/O (GPIO)

Device pins that are not connected to a specific peripheral function are controlled by the GPIO registers. Pins may be dynamically configured as inputs or outputs. Multiple outputs can be set or cleared in one write operation.

LPC802 use accelerated GPIO functions:

- GPIO registers are on the ARM Cortex-M0+ IO bus for fastest possible single-cycle I/O timing, allowing GPIO toggling with rates of up to 7 MHz.
- An entire port value can be written in one instruction.
- · Mask, set, and clear operations are supported for the entire port.

All GPIO port pins are fixed-pin functions that are enabled or disabled on the pins by the switch matrix. Therefore each GPIO port pin is assigned to one specific pin and cannot be moved to another pin. Except for pins SWDIO/PIO0_2, SWCLK/PIO0_3, and RESET/PIO0_5, the switch matrix enables the GPIO port pin function by default.

9.10.1 Features

- Bit level port registers allow a single instruction to set and clear any number of bits in one write operation.
- · Direction control of individual bits.
- All I/O default to GPIO inputs with internal pull-up resistors enabled after reset.
- Pull-up/pull-down configuration, repeater, and open-drain modes can be programmed through the IOCON block for each GPIO pin (see Figure 10).
- Direction (input/output) can be set and cleared individually.
- Pin direction bits can be toggled.

9.11 Pin interrupt

The pin interrupt block configures up to eight pins from all digital pins for providing eight external interrupts connected to the NVIC.

Any digital pin, independently of the function selected through the switch matrix, can be configured through the SYSCON block as input to the pin interrupt. The registers that control the pin interrupt are on the IO+ bus for fast single-cycle access.

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9.11.1 Features

- Pin interrupts
 - Up to eight pins can be selected from all digital pins as edge- or level-sensitive interrupt requests. Each request creates a separate interrupt in the NVIC.
 - Edge-sensitive interrupt pins can interrupt on rising or falling edges or both.
 - Level-sensitive interrupt pins can be HIGH- or LOW-active.
 - Pin interrupts can wake up the LPC802 from sleep mode, deep-sleep mode, and power-down mode.

9.12 USART0/1

All USART functions are movable functions and are assigned to pins through the switch matrix.

9.12.1 Features

- Maximum bit rates of 1.875 Mbit/s in asynchronous mode and 10 Mbit/s in synchronous mode for USART functions connected to all digital pins.
- 7, 8, or 9 data bits and 1 or 2 stop bits.
- Synchronous mode with master or slave operation. Includes data phase selection and continuous clock option.
- Multiprocessor/multidrop (9-bit) mode with software address compare. (RS-485 possible with software address detection and transceiver direction control.)
- Parity generation and checking: odd, even, or none.
- · One transmit and one receive data buffer.
- RTS/CTS for hardware signaling for automatic flow control. Software flow control can be performed using Delta CTS detect, Transmit Disable control, and any GPIO as an RTS output.
- Received data and status can optionally be read from a single register.
- · Break generation and detection.
- Receive data is 2 of 3 sample "voting". Status flag set when one sample differs.
- · Built-in Baud Rate Generator.
- A fractional rate divider is shared among all UARTs.
- Interrupts available for Receiver Ready, Transmitter Ready, Receiver Idle, change in receiver break detect, Framing error, Parity error, Overrun, Underrun, Delta CTS detect, and receiver sample noise detected.
- Separate data and flow control loopback modes for testing.
- Baud rate clock can also be output in asynchronous mode.

9.13 SPI0

All SPI functions are movable functions and are assigned to pins through the switch matrix.

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9.13.1 Features

- Maximum data rates of up to 15 Mbit/s in master mode and up to 18 Mbit/s in slave mode for SPI functions connected to all digital pins.
- Data frames of 1 to 16 bits supported directly. Larger frames supported by software.
- Master and slave operation.
- Data can be transmitted to a slave without the need to read incoming data, which can be useful while setting up an SPI memory.
- Control information can optionally be written along with data, which allows very versatile operation, including "any length" frames.
- One Slave Select input/output with selectable polarity and flexible usage.

Remark: Texas Instruments SSI and National Microwire modes are not supported.

9.14 I2C-bus interface (I2C0)

The I²C-bus is bidirectional for inter-IC control using only two wires: a serial clock line (SCL) and a serial data line (SDA). Each device is recognized by a unique address and can operate as either a receiver-only device (e.g., an LCD driver) or a transmitter with the capability to both receive and send information (such as memory). Transmitters and/or receivers can operate in either master or slave mode, depending on whether the chip has to initiate a data transfer or is only addressed. The I²C is a multi-master bus and can be controlled by more than one bus master.

9.14.1 Features

- I2C0 supports standard and fast mode with data rates of up to 400 kbit/s.
- · Independent Master, Slave, and Monitor functions.
- Supports both Multi-master and Multi-master with Slave functions.
- Multiple I²C slave addresses supported in hardware.
- One slave address can be selectively qualified with a bit mask or an address range in order to respond to multiple I²C bus addresses.
- 10-bit addressing supported with software assist.
- Supports SMBus.

9.15 CTimer

9.15.1 General-purpose 32-bit timers/external event counter

The LPC802 has one general-purpose 32-bit timer/counter.

The timer/counter is designed to count cycles of the system derived clock or an externally-supplied clock. It can optionally generate interrupts or perform other actions at specified timer values, based on four match registers. The timer/counter also includes three capture inputs to trap the timer value when an input signal transitions, optionally generating an interrupt.

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9.15.1.1 Features

- A 32-bit timer/counter with a programmable 32-bit prescaler.
- Counter or timer operation.
- Up to three 32-bit captures can take a snapshot of the timer value when an input signal transitions. A capture event may also optionally generate an interrupt. The number of capture inputs for each timer that are actually available on device pins can vary by device.
- Four 32-bit match registers that allow:
 - Continuous operation with optional interrupt generation on match.
 - Stop timer on match with optional interrupt generation.
 - Reset timer on match with optional interrupt generation.
 - Shadow registers are added for glitch-free PWM output.
- For each timer, up to 4 external outputs corresponding to match registers with the following capabilities (the number of match outputs for each timer that are actually available on device pins can vary by device):
 - Set LOW on match.
 - Set HIGH on match.
 - Toggle on match.
 - Do nothing on match.
- The timer and prescaler may be configured to be cleared on a designated capture
 event. This feature permits easy pulse width measurement by clearing the timer on
 the leading edge of an input pulse and capturing the timer value on the trailing edge.
- Up to 4 match registers can be configured for PWM operation, allowing up to 3 single edged controlled PWM outputs. (The number of match outputs for each timer that are actually available on device pins can vary by device.)

9.16 Multi-Rate Timer (MRT)

The Multi-Rate Timer (MRT) provides a repetitive interrupt timer with two channels. Each channel can be programmed with an independent time interval, and each channel operates independently from the other channels.

9.16.1 Features

- 31-bit interrupt timer
- · Two channels independently counting down from individually set values
- Bus stall, repeat and one-shot interrupt modes

9.17 Windowed WatchDog Timer (WWDT)

The watchdog timer resets the controller if software fails to service the watchdog timer periodically within a programmable time window.

9.17.1 Features

 Internally resets chip if not periodically reloaded during the programmable time-out period.

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- Optional windowed operation requires reload to occur between a minimum and maximum time period, both programmable.
- Optional warning interrupt can be generated at a programmable time prior to watchdog time-out.
- Enabled by software but requires a hardware reset or a watchdog reset/interrupt to be disabled.
- Incorrect feed sequence causes reset or interrupt if enabled.
- · Flag to indicate watchdog reset.
- · Programmable 24-bit timer with internal prescaler.
- Selectable time period from $(T_{cy(WDCLK)} \times 256 \times 4)$ to $(T_{cy(WDCLK)} \times 2^{24} \times 4)$ in multiples of $T_{cy(WDCLK)} \times 4$.
- The WatchDog Clock (WDCLK) is generated by the dedicated watchdog oscillator (WDOSC).

9.18 Self-Wake-up Timer (WKT)

The self-wake-up timer is a 32-bit, loadable down counter. Writing any non-zero value to this timer automatically enables the counter and launches a count-down sequence. When the counter is used as a wake-up timer, this write can occur prior to entering a reduced power mode.

9.18.1 Features

- 32-bit loadable down counter. Counter starts automatically when a count value is loaded. Time-out generates an interrupt/wake up request.
- The WKT supports three clock sources: an external clock on the WKTCLKIN pin, the low-power oscillator, and the FRO. The low-power oscillator can be used as the clock source in sleep, deep-sleep, and power-down modes.
- The WKT can be used for waking up the part from any reduced power mode or for general-purpose timing.

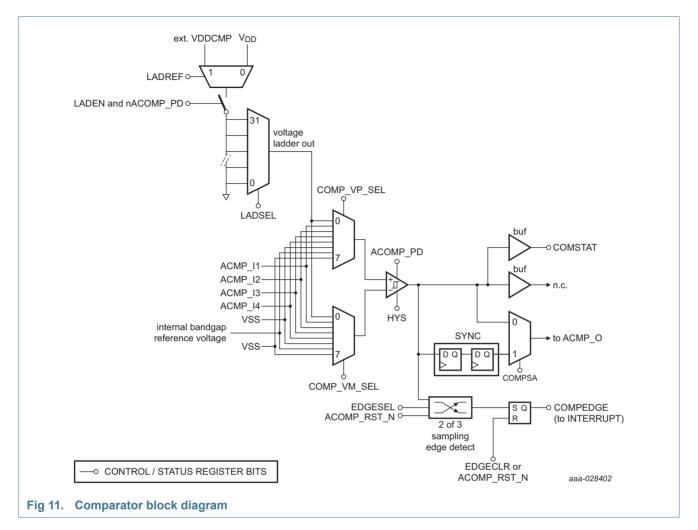
9.19 Analog comparator (ACMP)

The analog comparator with selectable hysteresis can compare voltage levels on external pins and internal voltages.

After power-up and after switching the input channels of the comparator, the output of the voltage ladder must be allowed to settle to its stable value before it can be used as a comparator reference input. Settling times are given in Table 27.

The analog comparator output is a movable function and is assigned to a pin through the switch matrix. The comparator inputs and the voltage reference are enabled through the switch matrix.

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9.19.1 Features

- Selectable 0 mV, 10 mV (\pm 5 mV), and 20 mV (\pm 10 mV), 40 mV (\pm 20 mV) input hysteresis.
- Two selectable external voltages (V_{DD} or ACMPV_{REF}); fully configurable on either positive or negative input channel.
- Internal voltage reference from band gap selectable on either positive or negative input channel.
- 32-stage voltage ladder with the internal reference voltage selectable on either the positive or the negative input channel.
- Voltage ladder source voltage is selectable from an external pin or the main 3.3 V supply voltage rail.
- Voltage ladder can be separately powered down for applications only requiring the comparator function.
- Interrupt output is connected to NVIC.
- Comparator level output is connected to output pin ACMP O.
- One comparator output is internally collected to the ADC trigger input multiplexer.

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9.20 Analog-to-Digital Converter (ADC)

The ADC supports a resolution of 12 bit and fast conversion rates of up to 480 KSamples/s. Sequences of analog-to-digital conversions can be triggered by multiple sources. Possible trigger sources are the pin triggers, the analog comparator output, and the ARM TXEV.

The ADC includes a hardware threshold compare function with zero-crossing detection.

Remark: For best performance, select VREFP and VREFN at the same voltage levels as V_{DD} and V_{SS} . When selecting VREFP and VREFN different from VDD and VSS, ensure that the voltage midpoints are the same:

 $(VREFP-VREFN)/2 + VREFN = V_{DD}/2$

9.20.1 Features

- 12-bit successive approximation analog to digital converter.
- 12-bit conversion rate of up to 480 KSamples/s.
- Two configurable conversion sequences with independent triggers.
- Optional automatic high/low threshold comparison and zero-crossing detection.
- Power-down mode and low-power operating mode.
- Measurement range VREFN to VREFP (not to exceed V_{DD} voltage level).
- · Burst conversion mode for single or multiple inputs.

9.21 CRC engine

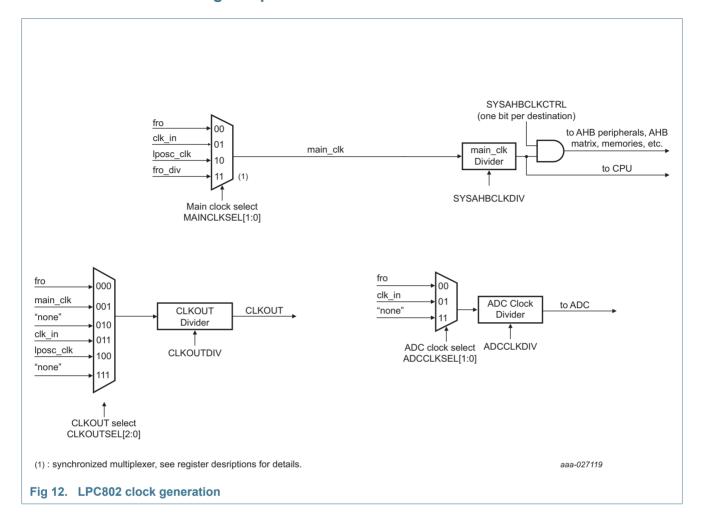
The Cyclic Redundancy Check (CRC) generator with programmable polynomial settings supports several CRC standards commonly used. To save system power and bus bandwidth, the CRC engine supports DMA transfers.

9.21.1 Features

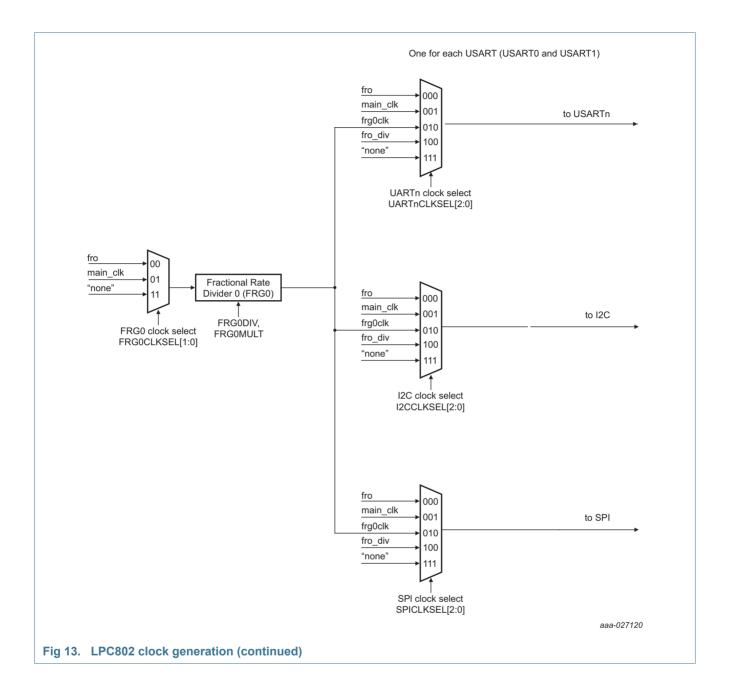
- Supports three common polynomials CRC-CCITT, CRC-16, and CRC-32.
 - CRC-CCITT: $x^{16} + x^{12} + x^5 + 1$
 - CRC-16: $x^{16} + x^{15} + x^2 + 1$
 - CRC-32: $x^{32} + x^{26} + x^{23} + x^{22} + x^{16} + x^{12} + x^{11} + x^{10} + x^8 + x^7 + x^5 + x^4 + x^2 + x + 1$
- Bit order reverse and 1's complement programmable setting for input data and CRC sum.
- · Programmable seed number setting.
- Supports CPU PIO or DMA back-to-back transfer.
- Accept any size of data width per write: 8, 16 or 32-bit.
 - 8-bit write: 1-cycle operation.
 - **–** 16-bit write: 2-cycle operation (8-bit x 2-cycle).
 - 32-bit write: 4-cycle operation (8-bit x 4-cycle).

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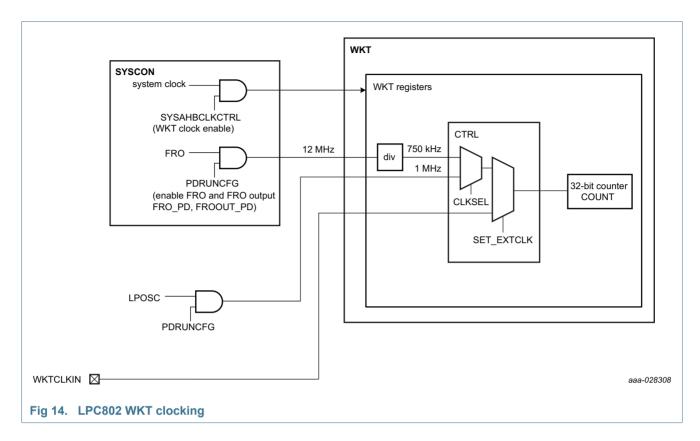
9.22 Clocking and power control



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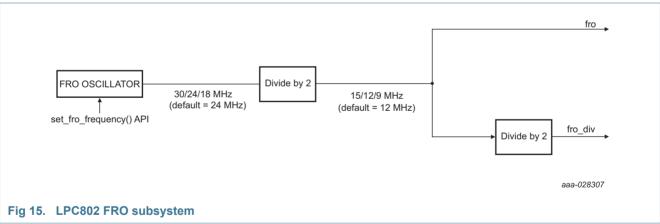


Table 6. Clocking diagram signal name descriptions

Name	Description
clk_in	The internal clock that comes from the main CLK_IN pin function. That function must be connected to the pin by selecting it in the SWM block.
frg_clk	The output of the Fractional Rate Generator. The FRG and its source selection are shown in Figure 13.
fro_div	Divided output of the currently selected on-chip FRO oscillator. See Figure 15.
fro	The output of the currently selected on-chip FRO oscillator. See Figure 15.

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Table 6. Clocking diagram signal name descriptions

Name	Description
main_clk	The main clock used by the CPU and AHB bus, and potentially many others. The main clock and its source selection are shown in Figure 12.
"none"	A tied-off source that should be selected to save power when the output of the related multiplexer is not used.
lposc_clk	The output of the 1 MHz low power oscillator. It must also be enabled in the PDRUNCFG0 register.

9.22.1 Internal oscillators

The LPC802 include two independent oscillators:

- 1. Free Running Oscillator.
- 2. Low power oscillator.

Following reset, the LPC802 operates from the FRO until switched by software allowing the part to run without any external clock and the bootloader code to operate at a known frequency.

See Figure 12 for an overview of the LPC802 clock generation.

9.22.1.1 Free Running Oscillator (FRO)

The FRO provides the default clock at reset and provides a clean system clock shortly after the supply pins reach operating voltage.

- This oscillator provides a selectable 15 MHz, 12 MHz, and 9 MHz outputs that can be used as a system clock. Also, these outputs can be divided down to 7.5 MHz, 6 MHz, and 4.5 MHz for system clock.
- The FRO is trimmed to ±1 % accuracy over the entire voltage and temperature range of 0 C to 70 C.
- By default, the FRO output frequency is default system (CPU) clock frequency of 12 MHz.

9.22.1.2 Low Power Oscillator (LPOsc)

The LPOsc is an independent oscillator which can be used as a system clock. The frequency of the LPCOsc is 1 MHz.

9.22.2 Clock input

An external clock source can be supplied on the selected CLKIN pin. When selecting a clock signal for the CLKIN pin, follow the specifications for digital I/O pins in <u>Table 12</u> "Static characteristics, supply pins" and Table 18 "Dynamic characteristics: I/O pins[1]".

The maximum frequency for both clock signals is 15 MHz.

9.22.3 Clock output

The LPC802 features a clock output function that routes any oscillator or the main clock can be selected to the CLKOUT function. The CLKOUT function can be connected to any digital pin through the switch matrix.

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9.22.4 Power control

The LPC802 supports the ARM Cortex-M0+ sleep mode. The CPU clock rate may also be controlled as needed by changing clock sources, and/or altering the CPU clock divider value. This allows a trade-off of power versus processing speed based on application requirements. In addition, a register is provided for shutting down the clocks to individual on-chip peripherals, allowing to fine-tune power consumption by eliminating all dynamic power use in any peripherals that are not required for the application. Selected peripherals have their own clock divider which provides even better power control.

9.22.4.1 Sleep mode

When sleep mode is entered, the clock to the core is stopped. Resumption from the sleep mode does not need any special sequence but re-enabling the clock to the ARM core.

In sleep mode, execution of instructions is suspended until either a reset or interrupt occurs. Peripheral functions continue operation during sleep mode and may generate interrupts to cause the processor to resume execution. sleep mode eliminates dynamic power used by the processor itself, memory systems and related controllers, and internal buses.

9.22.4.2 Deep-sleep mode

In deep-sleep mode, the LPC802 core is in sleep mode and all peripheral clocks and all clock sources are off except for the FRO or low-power oscillator if selected. The FRO output is disabled. In addition, all analog blocks are shut down and the flash is in standby mode. In deep-sleep mode, the application can keep the low power oscillator and the BOD circuit running for self-timed wakeup and BOD protection.

The LPC802 can wake up from deep-sleep mode via a reset, digital pins selected as inputs to the pin interrupt block, a watchdog timer interrupt, or an interrupt from the USART (if the USART is configured in synchronous slave mode), the SPI (in slave mode), or the I2C blocks (in slave mode).

Any interrupt used for waking up from deep-sleep mode must be enabled in one of the SYSCON wake-up enable registers and the NVIC.

Deep-sleep mode saves power and allows for short wake-up times.

9.22.4.3 Power-down mode

In power-down mode, the LPC802 is in sleep mode and all peripheral clocks and all clock sources are off except for low-power oscillator if selected. In addition, all analog blocks and the flash are shut down. In power-down mode, the application can keep the low-power oscillator and the BOD circuit running for self-timed wake up and BOD protection.

The LPC802 can wake up from power-down mode via a reset, digital pins selected as inputs to the pin interrupt block, a watchdog timer interrupt, or an interrupt from the USART (if the USART is configured in synchronous slave mode), the SPI (in slave mode), or the I2C blocks (in slave mode).

Any interrupt used for waking up from power-down mode must be enabled in one of the SYSCON wake-up enable registers and the NVIC.

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Power-down mode reduces power consumption compared to deep-sleep mode at the expense of longer wake-up times.

9.22.4.4 Deep power-down mode

In deep power-down mode, power is shut off to the entire chip except for the WAKEUP pins. The LPC802 can wake up from deep power-down mode via eight WAKEUP pins. See Section 9.18 "Self-Wake-up Timer (WKT)". Five general-purpose registers are available to store information during deep power-down mode.

The LPC802 can be prevented from entering deep power-down mode by setting a lock bit in the PMU block. Locking out deep power-down mode enables the application to keep the watchdog timer or the BOD running at all times.

When entering deep power-down mode, an external pull-up resistor is required on the WAKEUP pins to hold it HIGH.

Table 7. Peripheral configuration in reduced power modes

Peripheral	Sleep mode	Deep-sleep mode	Power-down mode	Deep power-down mode	
FRO	software configurable	on	off	off	
FRO output	software configurable	off	off	off	
Flash	software configurable	standby	off	off	
BOD	software configurable	software configurable	software configurable	off	
LPOsc/WWDT	software configurable	software configurable	software configurable	off	
Digital peripherals	software configurable	off	off	off	
Wake-up buffers	software configurable (cannot be used as wake-up source)	software configurable (cannot be used as wake-up source)	software configurable (cannot be used as wake-up source)	software configurable	
ADC	software configurable	off	off	off	

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Table 8. Wake-up sources for reduced power modes

power mode	Wake-up source	Conditions						
Sleep	Any interrupt	Enable interrupt in NVIC.						
Deep-sleep and	Pin interrupts	Enable pin interrupts in NVIC and STARTERP0 registers.						
power-down	BOD interrupt	Enable interrupt in NVIC and STARTERP1 registers.						
		Enable interrupt in BODCTRL register.						
		BOD powered in PDSLEEPCFG register.						
	BOD reset	Enable reset in BODCTRL register.						
		BOD powered in PDSLEEPCFG register.						
	WWDT interrupt	Enable interrupt in NVIC and STARTERP1 registers.						
		WWDT running. Enable WWDT in WWDT MOD register and feed.						
		Enable interrupt in WWDT MOD register.						
		LPOsc powered in PDSLEEPCFG register.						
	WWDT reset	WWDT running.						
		Enable reset in WWDT MOD register.						
		LPOsc powered in PDSLEEPCFG register.						
	Self-Wake-up Timer (WKT) time-out	Enable interrupt in NVIC and STARTERP1 registers.						
		 Enable low-power oscillator in the LPOSCCLKEN register in the SYSCON block. 						
		 Select low-power clock for WKT clock in the WKT CTRL register. 						
		Start the WKT by writing a time-out value to the WKT COUNT register.						
	Interrupt from	Enable interrupt in NVIC and STARTERP1 registers.						
	USART/SPI/I2C	Enable USART/I2C/SPI interrupts.						
	peripheral	Provide an external clock signal to the peripheral.						
		 Configure the USART in synchronous slave mode and I2C and SPI in slave mode. 						
Deep power-down	WAKEUP pins	Enable the WAKEUP function in the WUENAREG register in the PMU.						

9.22.5 Wake-up process

The LPC802 begin operation at power-up by using the FRO as the clock source allowing chip operation to resume quickly. If LPOsc or external clock sources are needed by the application, software must enable these features and wait for them to stabilize before they are used as a clock source.

9.23 System control

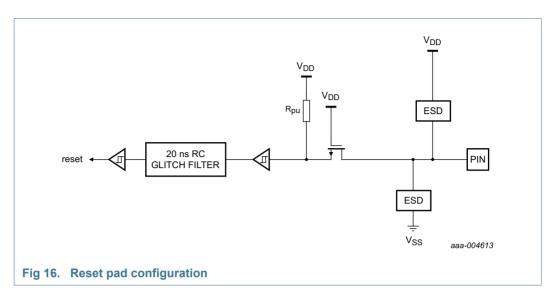
9.23.1 Reset

Reset has four sources on the LPC802: the RESET pin, the Watchdog reset, power-on reset (POR), and the BrownOut Detection (BOD) circuit. The RESET pin is a Schmitt trigger input pin. Assertion of chip reset by any source, once the operating voltage attains a usable level, starts the FRO and initializes the flash controller.

A LOW-going pulse as short as 50 ns resets the part.

When the internal Reset is removed, the processor begins executing at address 0, which is initially the Reset vector mapped from the boot block. At that point, all of the processor and peripheral registers have been initialized to predetermined values.

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9.23.2 Brownout detection

The LPC802 includes one reset level and three interrupt levels for monitoring the voltage on the V_{DD} pin. If this voltage falls below one of the selected levels, the BOD asserts an interrupt signal to the NVIC. This signal can be enabled for interrupt in the Interrupt Enable Register in the NVIC to cause a CPU interrupt. Alternatively, software can monitor the signal by reading a dedicated status register. One threshold level can be selected to cause a forced reset of the chip.

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9.23.3 Code security (Code Read Protection - CRP)

CRP provides different levels of security in the system so that access to the on-chip flash and use of the Serial Wire Debugger (SWD) and In-System Programming (ISP) can be restricted. Programming a specific pattern into a dedicated flash location invokes CRP. IAP commands are not affected by the CRP.

In addition, ISP entry via the ISP entry pin can be disabled without enabling CRP. For details, see the *LPC802 user manual*.

There are three levels of Code Read Protection:

- CRP1 disables access to the chip via the SWD and allows partial flash update (excluding flash sector 0) using a limited set of the ISP commands. This mode is useful when CRP is required and flash field updates are needed but all sectors cannot be erased.
- 2. CRP2 disables access to the chip via the SWD and only allows full flash erase and update using a reduced set of the ISP commands.
- 3. Running an application with level CRP3 selected, fully disables any access to the chip via the SWD pins and the ISP. This mode effectively disables ISP override using the ISP entry pin as well. If necessary, the application must provide a flash update mechanism using IAP calls or using a call to the reinvoke ISP command to enable flash update via the USART.

CAUTION



If level three Code Read Protection (CRP3) is selected, no future factory testing can be performed on the device.

In addition to the three CRP levels, sampling of the ISP entry pin for valid user code can be disabled. For details, see the *LPC802 user manual*.

9.23.4 APB interface

The APB peripherals are located on one APB bus.

9.23.5 **AHBLite**

The AHBLite connects the CPU bus of the ARM Cortex-M0+ to the flash memory, the main static RAM, the ROM, and the APB peripherals.

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9.24 Emulation and debugging

Debug functions are integrated into the ARM Cortex-M0+. Serial wire debug functions are supported in addition to a standard JTAG boundary scan. The ARM Cortex-M0+ is configured to support up to four breakpoints and two watch points.

The RESET pin selects between the JTAG boundary scan (RESET = LOW) and the ARM SWD debug (RESET = HIGH). The ARM SWD debug port is disabled while the LPC802 is in reset. The JTAG boundary scan pins are selected by hardware when the part is in boundary scan mode. See Table 4.

To perform boundary scan testing, follow these steps:

- 1. Erase any user code residing in flash.
- 2. Power up the part with the RESET pin pulled HIGH externally.
- 3. Wait for at least 250 μ s.
- 4. Pull the RESET pin LOW externally.
- 5. Perform boundary scan operations.
- 6. Once the boundary scan operations are completed, assert the TRST pin to enable the SWD debug mode, and release the RESET pin (pull HIGH).

Remark: The JTAG interface cannot be used for debug purposes.

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10. Limiting values

Table 9. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).[1]

Symbol	Parameter	Conditions		Min	Max	Unit
V_{DD}	supply voltage (core and external rail)		[2]	-0.5	+4.6	V
V _{ref}	reference voltage	on pin VREFP		-0.5	V_{DD}	V
VI	input voltage	5 V tolerant I/O pins; V _{DD} ≥ 1.71 V	[3][4]	-0.5	+5.4	V
		3 V tolerant I/O pin ACMPV _{REF}	[5]	-0.5	+3.6	V
V _{IA}	analog input voltage	on digital pins configured for an analog function	[6][7] [8]	-0.5	+4.6	V
I _{DD}	supply current	per supply pin (TSSOP20)		-	40	mA
		per supply pin (TSSOP16)		-	30	
		per supply pin (HVQFN33)		-	50	
		per supply pin (WLCSP16)		-	30	
I _{SS}	ground current	per ground pin (TSSOP20)		-	40	mA
		per ground pin (TSSOP16)		-	30	
		per ground pin (HVQFN33)		-	50	
		per supply pin (WLCSP16)		-	30	
I _{latch}	I/O latch-up current	$-(0.5V_{DD}) < V_I < (1.5V_{DD});$		-	100	mA
		T _j < 125 °C				
T _{stg}	storage temperature		[9]	-65	+150	°C
T _{j(max)}	maximum junction temperature			-	150	°C

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Table 9. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134).[1]

Symbol	Parameter	Conditions		Min	Max	Unit
P _{tot(pack)}	total power dissipation (per package)	TSSOP16, based on package heat transfer, not device power consumption.	[11]	-	0.29	W
		TSSOP16, based on package heat transfer, not device power consumption.	[12]	-	0.22	W
		TSSOP20, based on package heat transfer, not device power consumption.	[11]	-	0.36	W
		TSSOP20, based on package heat transfer, not device power consumption.	[12]	-	0.26	W
		HVQFN33, based on package heat transfer, not device power consumption.	[11]	-	0.91	W
		HVQFN33, based on package heat transfer, not device power consumption.	[12]	-	0.34	W
		WLCSP16, based on package heat transfer, not device power consumption.	[11]	-	0.65	W
		WLCSP16, based on package heat transfer, not device power consumption.	[12]	-	0.27	W
V _{esd}	electrostatic discharge voltage	human body model; all pins.	[10]	-	2000	V

- [1] The following applies to the limiting values:
 - a) This product includes circuitry specifically designed for the protection of its internal devices from the damaging effects of excessive static charge. Nonetheless, it is suggested that conventional precautions be taken to avoid applying greater than the rated maximum.
 - b) Parameters are valid over operating temperature range unless otherwise specified. All voltages are with respect to V_{SS} unless otherwise noted.
- [2] Maximum/minimum voltage above the maximum operating voltage (see <u>Table 12</u>) and below ground that can be applied for a short time (< 10 ms) to a device without leading to irrecoverable failure. Failure includes the loss of reliability and shorter lifetime of the device.
- [3] Applies to all 5 V tolerant I/O pins except the 3 V tolerant pin PIOO_7.
- [4] Including the voltage on outputs in 3-state mode.
- [5] V_{DD} present or not present.
- [6] An ADC input voltage above 3.6 V can be applied for a short time without leading to immediate, unrecoverable failure. Accumulated exposure to elevated voltages at 4.6 V must be less than 10⁶ s total over the lifetime of the device. Applying an elevated voltage to the ADC inputs for a long time affects the reliability of the device and reduces its lifetime.
- [7] If the comparator is configured with the common mode input V_{IC} = V_{DD}, the other comparator input can be up to 0.2 V above or below V_{DD} without affecting the hysteresis range of the comparator function.
- [8] It is recommended to connect an overvoltage protection diode between the analog input pin and the voltage supply pin.
- [9] Dependent on package type.
- [10] Human body model: equivalent to discharging a 100 pF capacitor through a 1.5 k Ω series resistor.
- [11] JEDEC (4.5 in \times 4 in); still air.
- [12] Single layer (4.5 in \times 3 in); still air.

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11. Thermal characteristics

The average chip junction temperature, T_j (°C), can be calculated using the following equation:

$$T_j = T_{amb} + (P_D \times R_{th(j-a)}) \tag{1}$$

- T_{amb} = ambient temperature (°C),
- R_{th(j-a)} = the package junction-to-ambient thermal resistance (°C/W)
- P_D = sum of internal and I/O power dissipation

The internal power dissipation is the product of I_{DD} and V_{DD} . The I/O power dissipation of the I/O pins is often small and many times can be negligible. However it can be significant in some applications.

Table 10. Thermal resistance

Symbol	Parameter	Conditions	Max/min	Unit
TSSOP20	package			
R _{th(j-a)}	thermal resistance from	JEDEC (4.5 in × 4 in); still air	110 ±15 %	°C/W
	junction-to-ambient	single-layer (4.5 in \times 3 in); still air	153 ±15 %	°C/W
R _{th(j-c)}	thermal resistance from junction-to-case		22 ±15 %	°C/W
TSSOP16	package			
R _{th(j-a)}	thermal resistance from	JEDEC (4.5 in × 4 in); still air	133 ±15 %	°C/W
	junction-to-ambient	single-layer (4.5 in \times 3 in); still air	182 ±15 %	°C/W
R _{th(j-c)}	thermal resistance from junction-to-case		32 ±15 %	°C/W
HVQFN33	package			
R _{th(j-a)}	thermal resistance from	JEDEC (4.5 in × 4 in); still air	43 ±15 %	°C/W
	junction-to-ambient	single-layer (4.5 in \times 3 in); still air	115 ±15 %	°C/W
R _{th(j-c)}	thermal resistance from junction-to-case		19 ±15 %	°C/W
WLCSP16	package			
R _{th(j-a)}	thermal resistance from	JEDEC (4.5 in × 4 in); still air	69.2 ±15 %	°C/W
	junction-to-ambient	single-layer (4.5 in \times 3 in); still air	168 ±15 %	°C/W
R _{th(j-c)}	thermal resistance from junction-to-case		1.1 ±15 %	°C/W

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12. Static characteristics

12.1 General operating conditions

Table 11. General operating conditions

 T_{amb} = -40 °C to +105 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
f _{clk}	clock frequency	internal CPU/system clock		-	-	15	MHz
	supply voltage (core			1.71	-	3.6	V
	and external rail)	For ADC operations		2.5	-	3.6	V
V_{DDIO}	I/O rail			1.71	-	3.6	V
		For ADC operations		2.5	-	3.6	V
V _{ref}	ADC positive reference voltage	on pin VREFP		2.5	-	V_{DD}	V
Pin capac	citance					'	'
C _{io}	input/output capacitance	pins with analog and digital functions	[2]	-	-	7.1	pF
		pins with digital functions only	[2]	-	-	2.8	pF

^[1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.

12.2 Power consumption

Power measurements in active, sleep, deep-sleep, and power-down modes were performed under the following conditions:

- Configure all pins as GPIO with pull-up resistor disabled in the IOCON block.
- Configure GPIO pins as outputs using the GPIO DIR register.
- Write 1 to the GPIO CLR register to drive the outputs LOW.

^[2] Including bonding pad capacitance. Based on simulation, not tested in production.

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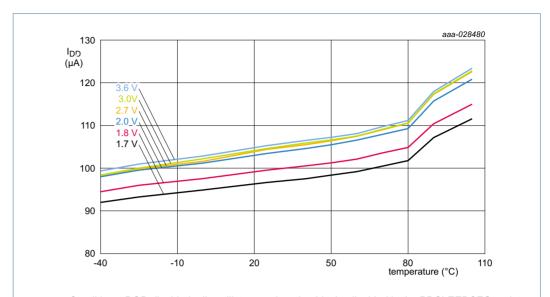
Table 12. Static characteristics, supply pins

 T_{amb} = -40 °C to +105 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1][2]	Max ^[9]	Unit
I _{DD}	supply current	Active mode; code					
		while(1){}					
		executed from flash;					
		system clock = 1 MHz V _{DD} = 3.3 V	[3][5][6][10]	-	0.5	-	mA
		system clock = 9 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	0.8	-	mA
		system clock = 12 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	1.0	-	mA
		system clock = 15 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	1.3	-	mA
		Sleep mode					
		system clock = 9 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	0.4	-	mA
	system clock = 12 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	0.5	-	mA	
		system clock = 15 MHz V _{DD} = 3.3 V	[3][4][5][6]	-	0.6	-	mA
I _{DD}	supply current	Deep-sleep mode; V _{DD} = 3.3 V;	[3][7]	-			
		T _{amb} = 25 °C			100	175	μΑ
		T _{amb} = 105 °C		-	-	240	μΑ
I _{DD}	supply current	Power-down mode; V _{DD} = 3.3 V	[3][7]	-			
		T _{amb} = 25 °C			6	14	μА
		T _{amb} = 105 °C		-	-	75	μА
I _{DD}	supply current	Deep power-down mode; V _{DD} = 3.3 V;	[8]				
		T _{amb} = 25 °C		-	0.15	0.5	μΑ
		T _{amb} = 105 °C				7	μА

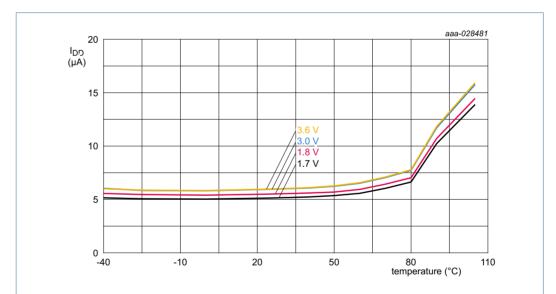
- [1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), V_{DD} = 3.3 V.
- [2] Characterized through bench measurements using typical samples.
- [3] I_{DD} measurements were performed with all pins configured as GPIO outputs driven LOW and pull-up resistors disabled.
- [4] FRO enabled.
- [5] BOD disabled.
- [6] All peripherals disabled in the SYSAHBCLKCTRL register. Peripheral clocks disabled in system configuration block.
- [7] All oscillators and analog blocks turned off.
- [8] WAKEUP function pin pulled HIGH externally.
- [9] Tested in production, VDD = 3.6 V.
- [10] LPOsc enabled, FRO disabled.

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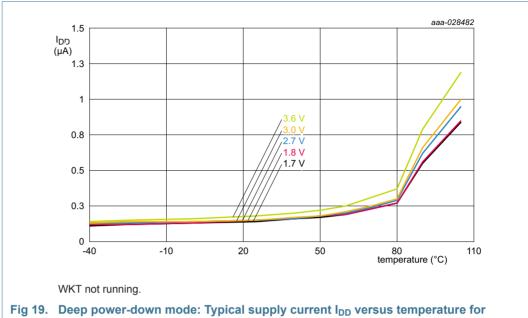
 $Conditions: BOD \ disabled; \ all \ oscillators \ and \ analog \ blocks \ disabled \ in \ the \ PDSLEEPCFG \ register.$

Fig 17. Deep-sleep mode: Typical supply current I_{DD} versus temperature for different supply voltages V_{DD}



Conditions: BOD disabled; all oscillators and analog blocks disabled in the PDSLEEPCFG register.

Fig 18. Power-down mode: Typical supply current I_{DD} versus temperature for different supply voltages V_{DD}



different supply voltages V_{DD}

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12.2.1 Peripheral power consumption

The supply current per peripheral is measured as the difference in supply current between the peripheral block enabled and the peripheral block disabled in the SYSAHBCLKCFG. and PDRUNCFG (for analog blocks) registers. All other blocks are disabled in both registers and no code accessing the peripheral is executed. Measured on a typical sample at T_{amb} = 25 °C.

The supply currents are shown for system clock frequencies of 12 MHz and 15 MHz.

Table 13. Power consumption for individual analog and digital blocks

Peripheral	Typical s	upply current in	μΑ	Notes
	System o	lock frequency	=	
	n/a	12 MHz	15 MHz	
FRO	74	-	-	FRO = 12MHz. FRO output disabled.
BOD	39	-	-	Independent of main clock frequency.
Flash	80	-	-	-
LPOsc	1	-	-	FRO; independent of main clock frequency.
GPIO + pin interrupt	-	40	54	GPIO pins configured as outputs and set to LOW. Direction and pin state are maintained if the GPIO is disabled in the SYSAHBCLKCFG register.
SWM	-	24	30	-
IOCON	-	28	36	-
CTimer	-	28	37	-
MRT	-	45	56	-
WWDT	-	31	41	-
I2C0	-	44	58	-
SPI0	-	33	42	-
USART0	-	39	46	-
USART1	-	40	50	-
Comparator ACMP	-	36	46	-
ADC	-	61	78	Digital controller only. Analog portion of the ADC disabled in the PDRUNCFG register.
	-	61	78	Combined analog and digital logic. ADC enabled in the PDRUNCFG register and LPWRMODE bit set to 1 in the ADC CTRL register (ADC in low-power mode).
	-	61	78	Combined analog and digital logic. ADC enabled in the PDRUNCFG register and LPWRMODE bit set to 0 in the ADC CTRL register (ADC powered).
CRC	-	37	50	-

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12.3 Pin characteristics

Table 14. Static characteristics, electrical pin characteristics

 T_{amb} = -40 °C to +105 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
Standard	port pins configured as d	ligital pins, RESET					
I _{IL}	LOW-level input current	V _I = 0 V; on-chip pull-up resistor disabled		-	0.5	10[2]	nA
I _{IH}	HIGH-level input current	$V_I = V_{DD}$; on-chip pull-down resistor disabled		-	0.5	10[2]	nA
l _{OZ}	OFF-state output current	$V_O = 0 \text{ V}; V_O = V_{DD}; \text{ on-chip}$ pull-up/down resistors disabled		-	0.5	10[2]	nA
VI	input voltage	V _{DD} ≥ 1.71 V; 5 V tolerant pins except PIO0_7		0	-	5.4	V
		V _{DD} = 0 V		0	-	3.6	V
V _O	output voltage	output active		0	-	V_{DD}	V
V_{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{DD}	V
V _{hys}	hysteresis voltage			-	0.4	-	V
V _{OH}	HIGH-level output	I _{OH} = 4 mA; 2.5 V <= V _{DD} <= 3.6 V		$V_{DD} - 0.4$	-	-	٧
	voltage	I _{OH} = 3 mA; 1.71 V <= V _{DD} < 2.5 V		$V_{DD} - 0.5$	-	-	V
V _{OL}	LOW-level output	I _{OL} = 4 mA; 2.5 V <= V _{DD} <= 3.6 V		-	-	0.5	V
voltage	voltage	I _{OL} = 3 mA; 1.71 V <= V _{DD} < 2.5 V		-	-	0.5	V
I _{OH}	HIGH-level output current	$V_{OH} = V_{DD} - 0.4 \text{ V};$ 2.5 V \leq V _{DD} \leq 3.6 V		4	-	-	mA
		$V_{OH} = V_{DD} - 0.5 \text{ V};$ 1.71 V \le V_{DD} \le 2.5 V		3	-	-	mA
I _{OL}	LOW-level output current	$V_{OL} = 0.5 \text{ V}$ 2.5 V \le V_{DD} \le 3.6 V		4	-	-	mA
		1.71 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OHS}	HIGH-level short-circuit output current	V _{OH} = 0 V	[3]	-	-	45	mA
I _{OLS}	LOW-level short-circuit output current	$V_{OL} = V_{DD}$	[3]	-	-	50	mA
I _{pd}	pull-down current	V _I = 5 V	[4]	10	50	150	μΑ
I _{pu}	pull-up current	V _I = 0 V;	[4]				
		$2.0~V \leq V_{DD} \leq 3.6~V$		10	50	90	μΑ
		1.71 V ≤ V _{DD} < 2.0 V		7	50	85	μΑ
		V _{DD} < V _I < 5 V		0	0	0	μА
High-drive	e output pin configured a	s digital pin (PIO0_2, PIO0_3, and F	PIO0_12)				
I _{IL}	LOW-level input current	V _I = 0 V; on-chip pull-up resistor disabled		-	0.5	10[2]	nA
I _{IH}	HIGH-level input current	$V_I = V_{DD}$; on-chip pull-down resistor disabled		-	0.5	10[2]	nA
		1					_

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Table 14. Static characteristics, electrical pin characteristics ...continued

 T_{amb} = -40 °C to +105 °C, unless otherwise specified.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
l _{OZ}	OFF-state output current	$V_O = 0 \text{ V}; V_O = V_{DD}; \text{ on-chip}$ pull-up/down resistors disabled		-	0.5	10[2]	nA
VI	input voltage	$V_{DD} \ge 1.8 \text{ V}$		0	-	5.0	V
		V _{DD} = 0 V		0	-	3.6	V
Vo	output voltage	output active		0	-	V_{DD}	V
V _{IH}	HIGH-level input voltage			0.7V _{DD}	-	-	V
V _{IL}	LOW-level input voltage			-	-	0.3V _{DD}	V
V _{hys}	hysteresis voltage			-	0.4	-	V
	HIGH-level output	I _{OH} = 20 mA; 2.5 V <= V _{DD} < 3.6 V		$V_{DD} - 0.6$	-	-	V
	voltage	I _{OH} = 12 mA; 1.71 V <= V _{DD} < 2.5 V		$V_{DD} - 0.6$	-	-	V
V _{OL}	LOW-level output voltage	I _{OL} = 4 mA; 2.5 V <= V _{DD} <= 3.6 V I _{OL} = 3 mA; 1.71 V <= V _{DD} < 2.5 V		-	-	0.5	V
I _{OH}	HIGH-level output current	$V_{OH} = V_{DD} - 0.6 \text{ V};$ 2.5 V <= $V_{DD} < 3.6 \text{ V}$		20	-	-	mA
		V _{OH} = V _{DD} - 0.6 V; 1.71 V <= V _{DD} < 2.5 V		12	-	-	mA
I _{OL}	LOW-level output current	$V_{OL} = 0.5 \text{ V}$ 2.5 V \le V_{DD} \le 3.6 V		4	-	-	mA
		1.71 V ≤ V _{DD} < 2.5 V		3	-	-	mA
I _{OLS}	LOW-level short-circuit output current	$V_{OL} = V_{DD}$	[3]	-	-	50	mA
I _{pd}	pull-down current	V _I = 5 V	[4]	10	50	150	μΑ
I _{pu}	pull-up current	V _I = 0 V;	<u>[4]</u>				μΑ
		$2.0~V \leq V_{DD} \leq 3.6~V$		10	50	90	μΑ
		1.71 V ≤ V _{DD} < 2.0 V		7	50	85	μΑ
		V _{DD} < V _I < 5 V		0	0	0	μΑ

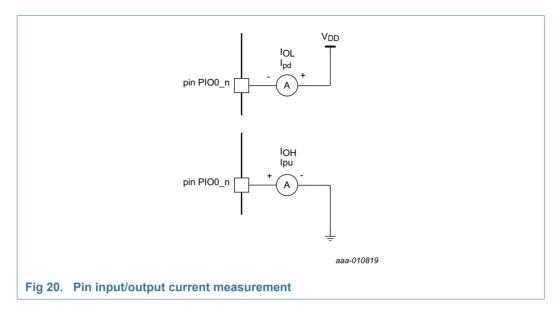
^[1] Typical ratings are not guaranteed. The values listed are for room temperature (25 °C), nominal supply voltages.

^[2] Based on characterization. Not tested in production.

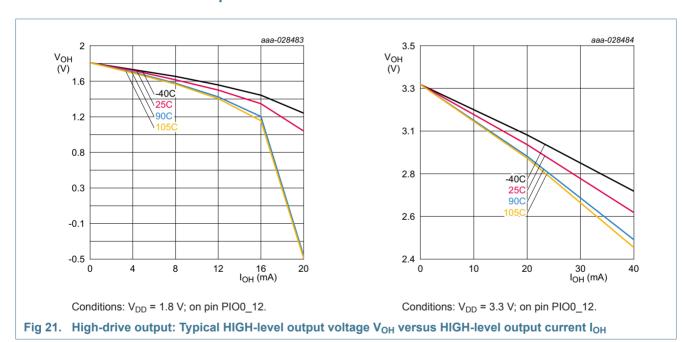
^[3] Allowed as long as the current limit does not exceed the maximum current allowed by the device.

^[4] Pull-up and pull-down currents are measured across the weak internal pull-up/pull-down resistors. See Figure 20.

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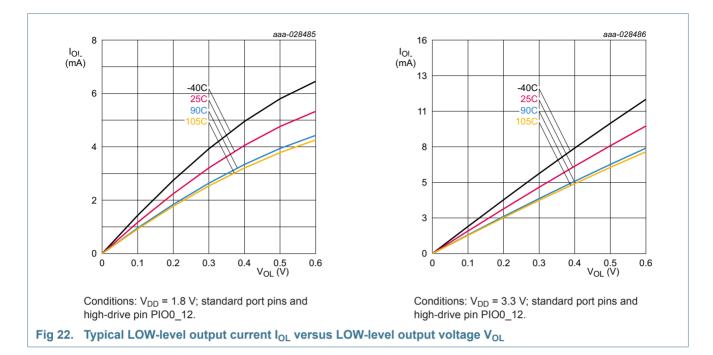


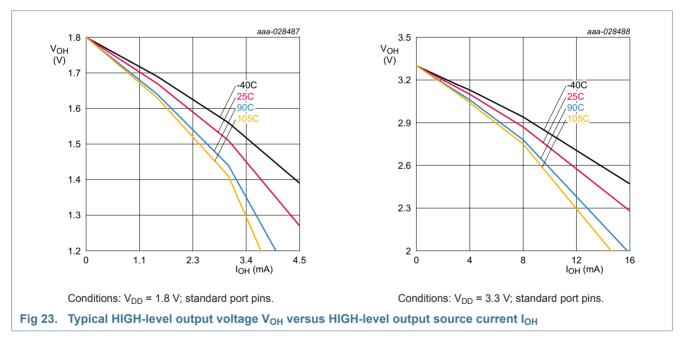
12.3.1 Electrical pin characteristics

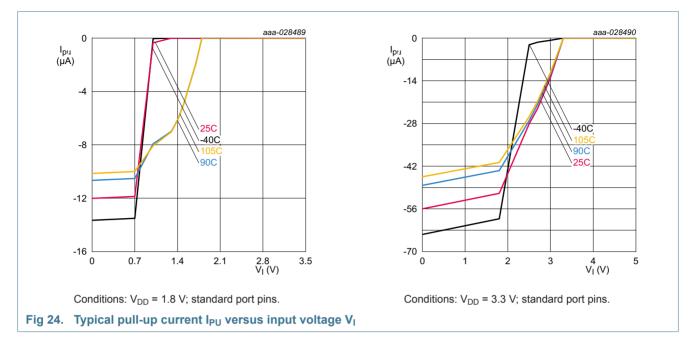


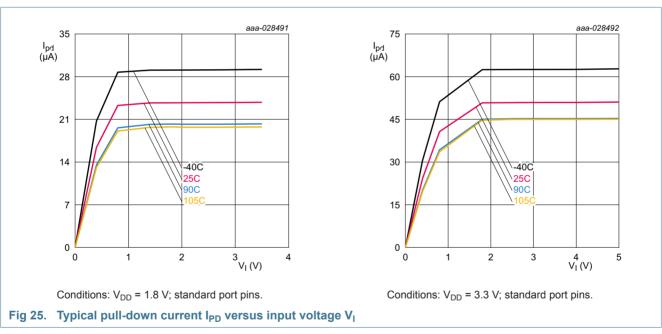
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13. Dynamic characteristics

13.1 Flash memory (EEPROM based)

Table 15. Flash characteristics

 T_{amb} = -40 °C to +105 °C. Based on JEDEC NVM qualification.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
N _{endu}	endurance		[1]	200,000	500,000	-	cycles
t _{ret}	retention time	powered		10	-	-	years
		not powered		20	-	-	years
t _{er}	erase time	page or multiple consecutive pages, sector or multiple consecutive sectors		-	1.03	-	ms
t _{prog}	programming time		[2]	-	2.5	-	ms

^[1] Number of program/erase cycles.

13.2 FRO

Table 16. Dynamic characteristic: FRO

 $T_{amb} = -40 \, ^{\circ}\text{C} \text{ to } +105 \, ^{\circ}\text{C}; \ 1.7 \, \text{V} \leq V_{DD} \leq 3.6 \, \text{V}.$

Symbol	Min	Typ[1]	Max	Unit
FRO clock freque	ncy; Condition: 0 °C ≤	≤ T _{amb} ≤ 70 °C		
f _{osc(RC)}	9 -1 %	9	9 +1 %	MHz
f _{osc(RC)}	12 -1 %	12	12 +1 %	MHz
f _{osc(RC)}	15 -1 %	15	15 +1 %	MHz
FRO clock freque	ncy; Condition: –20	°C ≤ T _{amb} ≤ 70 °C		
f _{osc(RC)}	9 -2 %	9	9 +1 %	MHz
f _{osc(RC)}	12 -2 %	12	12 +1 %	MHz
f _{osc(RC)}	15 -2 %	15	15 +1 %	MHz
FRO clock freque	ncy; Condition: –40	°C ≤ T _{amb} ≤ 105 °C		
f _{osc(RC)}	9 -3.5 %	9	9 +2.5 %	MHz
f _{osc(RC)}	12 -3.5 %	12	12 +2.5 %	MHz
f _{osc(RC)}	15 -3.5 %	15	15 +2.5 %	MHz

^[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 $^{\circ}$ C), nominal supply voltages.

^[2] Programming times are given for writing 64 bytes to the flash. T_{amb} <= +85 °C. Flash programming with IAP calls (see LPC802 user manual).</p>

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Table 17. Dynamic characteristic: LPOsc

 $T_{amb} = -40 \, ^{\circ}\text{C} \text{ to } +105 \, ^{\circ}\text{C}; 1.71 \, \text{V} \leq V_{DD} \leq 3.6 \, \text{V}.$

Symbol	Parameter	Conditions	Min	Typ[1]	Max	Unit
f _{osc(RC)}	LPOsc clock frequency	-	1 -3%	1	1 +3%	MHz

^[1] Typical ratings are not guaranteed. The values listed are at room temperature (25 °C), nominal supply voltages.

13.3 I/O pins

Table 18. Dynamic characteristics: I/O pins[1]

 $T_{amb} = -40 \, ^{\circ}\text{C} \text{ to } +105 \, ^{\circ}\text{C}; 3.0 \, \text{V} \leq V_{DD} \leq 3.6 \, \text{V}.$

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _r	rise time	pin configured as output	3.0	-	5.0	ns
t _f	fall time	pin configured as output	2.5	-	5.0	ns

^[1] Applies to standard port pins and \overline{RESET} pin.

13.4 WKTCLKIN pin (wake-up clock input)

Table 19. Dynamic characteristics: WKTCLKIN pin

 $T_{amb} = -40 \, ^{\circ}\text{C} \text{ to } +105 \, ^{\circ}\text{C}; \ 1.71 \, \text{V} \leq V_{DD} \, \leq 3.6 \, \text{V}.$

Symbol	Parameter	Conditions		Min	Max	Unit
f _{clk}	clock frequency	power-down, deep-sleep, and active mode	[1]	-	10	MHz
t _{CHCX}	clock HIGH time	-		50	-	ns
t _{CLCX}	clock LOW time	-		50	-	ns

^[1] Assuming a square-wave input clock.

13.5 I2C-bus

Table 20. Dynamic characteristic: I²C-bus pins[1]

 T_{amb} = -40 °C to +105 °C; values guaranteed by design.[2]

Symbol	Parameter		Conditions	Min	Max	Unit
f _{SCL}	SCL clock		Standard-mode	0	100	kHz
	frequency		Fast-mode	0	400	kHz
t _f	fall time	[4][5][6]	of both SDA and SCL signals	-	300	ns
			Standard-mode			
			Fast-mode	20 + 0.1 × C _b	300	ns
t _{LOW}	LOW period of		Standard-mode	4.7	400	μS
	the SCL clock		Fast-mode	1.3	-	μS
t _{HIGH}	HIGH period of		Standard-mode	4.0	-	μS
	the SCL clock		Fast-mode	0.6	-	μS

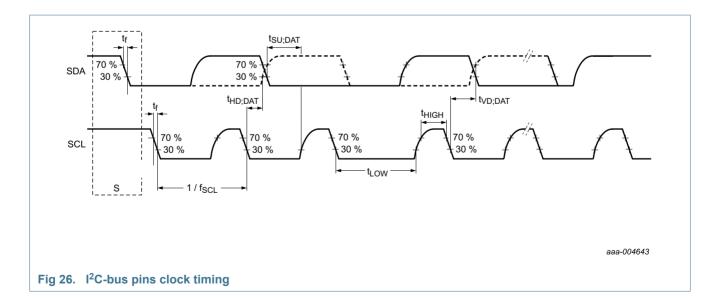
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Table 20. Dynamic characteristic: I²C-bus pins[1]

 T_{amb} = -40 °C to +105 °C; values guaranteed by design.[2]

Symbol	Parameter		Conditions	Min	Max	Unit
t _{HD;DAT}	data hold time	[3][4][7]	Standard-mode	0	-	μS
			Fast-mode	0	-	μS
t _{SU;DAT}	data set-up	[8][9]	Standard-mode	250	-	ns
	time		Fast-mode	100	-	ns

- [1] See the I²C-bus specification *UM11045* for details.
- [2] Parameters are valid over operating temperature range unless otherwise specified.
- [3] t_{HD;DAT} is the data hold time that is measured from the falling edge of SCL; applies to data in transmission and the acknowledge.
- [4] A device must internally provide a hold time of at least 300 ns for the SDA signal (with respect to the V_{IH}(min) of the SCL signal) to bridge the undefined region of the falling edge of SCL.
- [5] $C_b = \text{total capacitance of one bus line in pF.}$
- [6] The maximum t_f for the SDA and SCL bus lines is specified at 300 ns. The maximum fall time for the SDA output stage t_f is specified at 250 ns. This allows series protection resistors to be connected in between the SDA and the SCL pins and the SDA/SCL bus lines without exceeding the maximum specified t_f.
- [7] The maximum t_{HD;DAT} could be 3.45 μs and 0.9 μs for Standard-mode and Fast-mode but must be less than the maximum of t_{VD;DAT} or t_{VD;ACK} by a transition time (see *UM10204*). This maximum must only be met if the device does not stretch the LOW period (t_{LOW}) of the SCL signal. If the clock stretches the SCL, the data must be valid by the set-up time before it releases the clock.
- [8] t_{SU;DAT} is the data set-up time that is measured with respect to the rising edge of SCL; applies to data in transmission and the acknowledge.
- [9] A Fast-mode I²C-bus device can be used in a Standard-mode I²C-bus system but the requirement t_{SU;DAT} = 250 ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line t_{r(max)} + t_{SU;DAT} = 1000 + 250 = 1250 ns (according to the Standard-mode I²C-bus specification) before the SCL line is released. Also the acknowledge timing must meet this set-up time.



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13.6 SPI interfaces

The actual SPI bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading. Excluding delays introduced by external device and PCB, the maximum supported bit rate for SPI master mode is 15 Mbit/s, and the maximum supported bit rate for SPI slave mode is $1/(2 \times 28 \text{ ns}) = 17.8 \text{ Mbit/s}$ at $3.0v \le \text{VDD} \le 3.6v$ and $1/(2 \times 32 \text{ ns}) = 15.6 \text{ Mbit/s}$ at $1.7v \le \text{VDD} \le 3.6v$

Remark: SPI functions can be assigned to all digital pins. The characteristics are valid for all digital pins.

Table 21. SPI dynamic characteristics

 T_{amb} = -40 °C to 105 °C; C_L = 20 pF; input slew = 1 ns. Simulated parameters sampled at the 30 % and 70 % level of the rising or falling edge; values guaranteed by design. Delays introduced by the external trace or external device are not considered.

Symbol	Parameter	Conditions	Min	Max	Unit
SPI mast	er			'	'
t _{DS}	data set-up time	1.71 V <= V _{DD} <= 3.6 V	10	-	ns
t _{DH}	data hold time	1.71 V <= V _{DD} <= 3.6 V	7	-	ns
t _{v(Q)}	data output valid time	1.71 V <= V _{DD} <= 3.6 V	0	2	ns
SPI slave	,		'	'	'
t _{DS}	data set-up time	1.71 V <= V _{DD} <= 3.6 V	10	-	ns
t _{DH}	data hold time	1.71 V <= V _{DD} <= 3.6 V	7	-	ns
t _{v(Q)}	data output valid time	3.0 V <= V _{DD} <= 3.6 V	0	28	ns
		1.71 V <= V _{DD} < 3.0 V	0	32	ns

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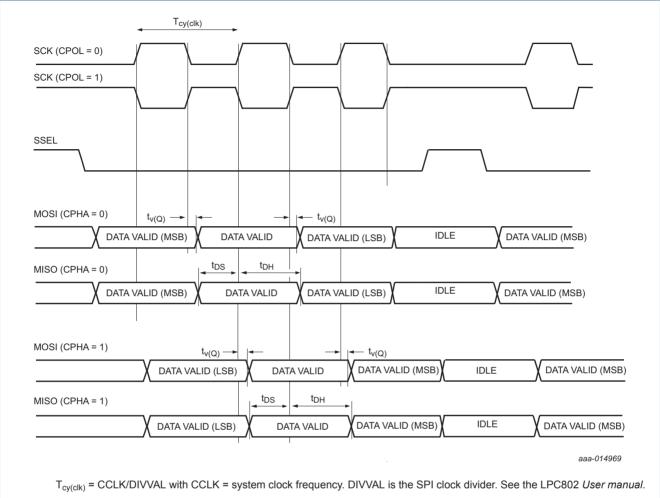
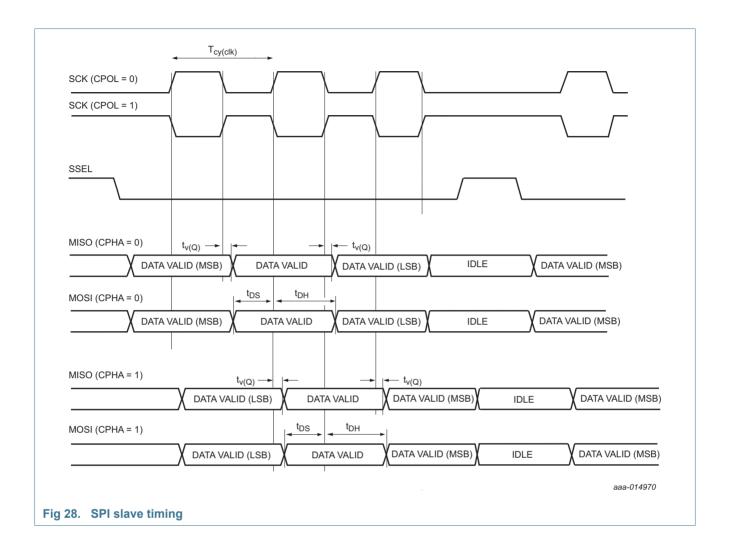


Fig 27. SPI master timing

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13.7 USART interface

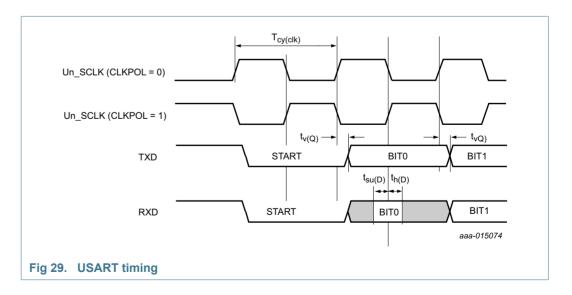
The actual USART bit rate depends on the delays introduced by the external trace, the external device, system clock (CCLK), and capacitive loading. Excluding delays introduced by external device and PCB, the maximum supported bit rate for USART master synchronous mode is 10 Mbit/s, and the maximum supported bit rate for USART slave synchronous mode is 10 Mbit/s.

Remark: USART functions can be assigned to all digital pins. The characteristics are valid for all digital pins

Table 22. USART dynamic characteristics

 T_{amb} = -40 °C to 105 °C; 1.71 V <= V_{DD} <= 3.6 V unless noted otherwise; C_L = 10 pF; input slew = 10 ns. Simulated parameters sampled at the 30 %/70 % level of the falling or rising edge; values guaranteed by design.

Symbol	Parameter	Conditions	Min	Max	Unit
USART master	(in synchronous mode)				
t _{su(D)}	data input set-up time	3.0 V <= V _{DD} <= 3.6 V	34	-	ns
		1.71 V <= V _{DD} < 3.0 V	36	-	ns
$t_{h(D)}$ data input hold time 3.0		3.0 V <= V _{DD} <= 3.6 V	0	-	ns
		1.71 V <= V _{DD} < 3.0 V	0	-	ns
$t_{V(Q)}$	data output valid time	3.0 V <= V _{DD} <= 3.6 V	0	7	ns
		1.71 V <= V _{DD} < 3.0 V	0	6	ns
USART slave (ir	n synchronous mode)				'
t _{su(D)}	data input set-up time	3.0 V <= V _{DD} <= 3.6 V	8	-	ns
		1.71 V <= V _{DD} < 3.0 V	3	-	ns
t _{h(D)}	data input hold time	3.0 V <= V _{DD} <= 3.6 V	10	-	ns
		1.71 V <= V _{DD} < 3.0 V	5	-	ns
$t_{v(Q)}$	data output valid time	3.0 V <= V _{DD} <= 3.6 V	0	39	ns
		1.71 V <= V _{DD} < 3.0 V	0	42	ns



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13.8 Wake-up process

Table 23. Dynamic characteristic: Typical wake-up times from low power modes $V_{DD} = 3.3 \ V; T_{amb} = 25 \ ^{\circ}C; \ Using FRO (15 \ MHz)$ as the system clock.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
t _{wake}	wake-up	from sleep mode	[2][3]	-	1.97	-	μS
	time	from deep-sleep mode	[2]	-	2.07	-	μS
		from power-down mode	[2]	-	25	-	μS
		from deep power-down mode	[4]	-	313	-	μS

- [1] Typical ratings are not guaranteed. The values listed are at room temperature (25 $^{\circ}$ C), nominal supply voltages.
- [2] The wake-up time measured is the time between when a GPIO input pin is triggered to wake the device up from the low power modes and from when a GPIO output pin is set in the interrupt service routine (ISR) wake-up handler. ISR is located in SRAM.
- [3] FRO enabled, all peripherals off.
- [4] Wake up from deep power-down causes the part to go through entire reset process. The wake-up time measured is the time between when the Wake-Up pin is triggered to wake the device up and when a GPIO output pin is set in the reset handler.

14. Characteristics of analog peripherals

14.1 BOD

Table 24. BOD static characteristics[1]

 $T_{amb} = 25 \, ^{\circ}C.$

Symbol	Parameter	Conditions	Mi	in	Тур	Max	Unit
V_{th}	threshold voltage	interrupt level 1					
		assertion	-		2.24	-	V
		de-assertion	-		2.40	-	V
		interrupt level 2					
		assertion	-		2.52	-	V
		de-assertion	-		2.64	-	V
		interrupt level 3					
		assertion	-		2.81	-	V
		de-assertion	-		2.90	-	V
		reset level 0					
		assertion	-		1.51	-	V
		de-assertion	-		1.54	-	V

^[1] Interrupt levels are selected by writing the level value to the BOD control register BODCTRL, see the LPC802 user manual.

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14.2 ADC

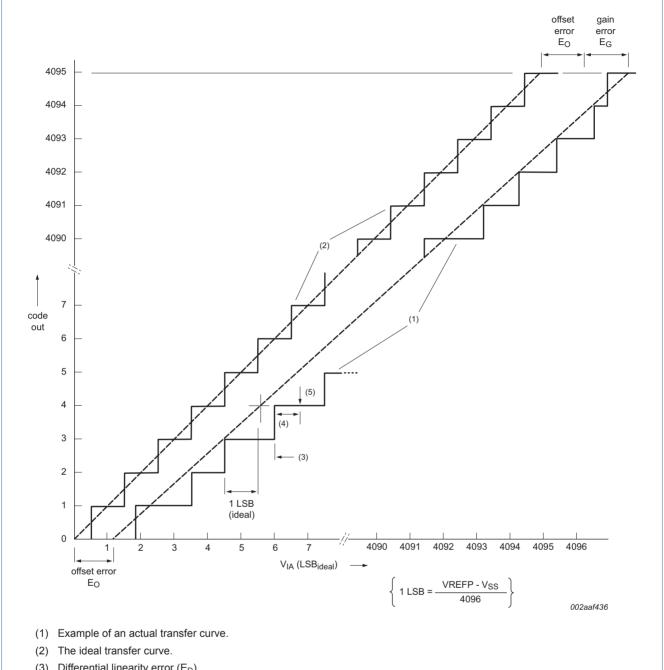
Table 25. 12-bit ADC static characteristics

 T_{amb} = -40 °C to +105 °C unless noted otherwise; V_{DD} = 2.5 V to 3.6 V; VREFP = V_{DD} ; VREFN = V_{SS} .

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{IA}	analog input voltage			0	-	V_{DD}	V
V _{ref}	reference voltage	on pin VREFP		2.5	-	V_{DD}	V
C _{ia}	analog input capacitance			-	-	26	pF
f _{clk(ADC)}	ADC clock frequency		[2]	-	-	15	MHz
fs	sampling frequency		[2]	-	-	480	Ksamples/s
E _D	differential linearity error		[5][4]	-	±1	-	LSB
E _{L(adj)}	integral non-linearity		[6][4]	-	±4	-	LSB
Eo	offset error		[7][4]	-	±3	-	LSB
V _{err(fs)}	full-scale error voltage		[8][4]	-	0.1	-	%
Z _i	input impedance	f _s = 480 Ksamples/s	[1][9] [10]	0.1	-	-	ΜΩ

- [1] The input resistance of ADC channel 0 is higher than for all other channels. See Figure 30.
- [2] In the ADC TRM register, set VRANGE = 0 (default).
- [3] In the ADC TRM register, set VRANGE = 1 (default).
- [4] Based on characterization. Not tested in production.
- [5] The differential linearity error (ED) is the difference between the actual step width and the ideal step width. See Figure 30.
- [6] The integral non-linearity (E_{L(adj)}) is the peak difference between the center of the steps of the actual and the ideal transfer curve after appropriate adjustment of gain and offset errors. See Figure 30.
- [7] The offset error (E_O) is the absolute difference between the straight line which fits the actual curve and the straight line which fits the ideal curve. See Figure 30.
- [8] The full-scale error voltage or gain error (E_G) is the difference between the straight line fitting the actual transfer curve after removing offset error, and the straight line which fits the ideal transfer curve. See Figure 30.
- [9] $T_{amb} = 25 \,^{\circ}\text{C}$; maximum sampling frequency $f_s = 480 \,^{\circ}\text{Ksamples/s}$ and analog input capacitance $C_{ia} = 26 \,^{\circ}\text{F}$.
- [10] Input impedance Z_i (see Section 14.2.1) is inversely proportional to the sampling frequency and the total input capacity including C_{ia} and C_{io} : $Z_i \propto 1 / (f_s \times C_i)$. See Table 12 for C_{io} .

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- (3) Differential linearity error (E_D).
- (4) Integral non-linearity $(E_{L(adj)})$.
- (5) Center of a step of the actual transfer curve.

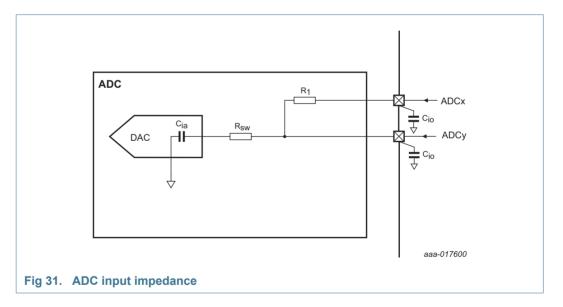
Fig 30. 12-bit ADC characteristics

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14.2.1 ADC input impedance

Figure 31 shows the ADC input impedance. In this figure:

- ADCx represents ADC input channel 0.
- ADCy represents ADC input channels 1 to 11.
- R₁ and R_{sw} are the switch-on resistance on the ADC input channel.
- If ADC input channel 0 is selected, the ADC input signal goes through R₁ + R_{sw} to the sampling capacitor (C_{ia}).
- If ADC input channels 1 to 11 are selected, the ADC input signal goes through R_{sw} to the sampling capacitor (C_{ia}).
- Typical values, $R_1 = 5.6 \text{ k}\Omega$, $R_{sw} = 6.9 \text{ k}\Omega$
- To calculate total resistance, use the following equation:
 - R_{TOTAL} = R_{external} + R_{internal}
 - R_{external} = External resistance on the ADC input channel.
 - $R_{internal}$ for channel 0 = $R_1 + R_{SW}$ = 12.5 k Ω .
 - $R_{internal}$ for channels 1 to 11 = 6.9 k Ω .
- See Table 11 for C_{io}.
- See Table 25 for C_{ia}.



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14.3 Comparator and internal voltage reference

Table 26. Internal voltage reference static and dynamic characteristics

T_{amb} = −40 °C to +105 °C; V_{DD} = 3.3 V; hysteresis disabled in the comparator CTRL register.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Vo	output voltage	T _{amb} = 25 °C to 105°C	860	-	940	mV
		T _{amb} = 25 °C		904		mV

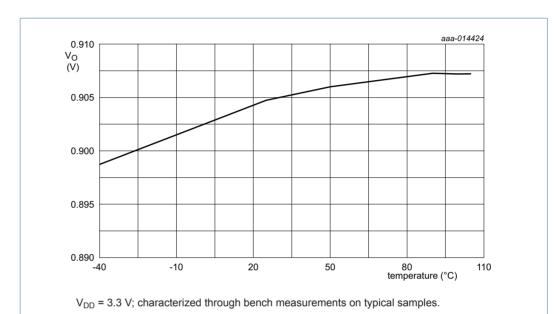


Fig 32. Typical internal voltage reference output voltage

Table 27. Comparator characteristics

 T_{amb} = -40 °C to +105 °C unless noted otherwise; V_{DD} = 1.71 V to 3.6 V.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static cha	aracteristics						
V _{ref(cmp)}	comparator reference voltage	pin ACMPV _{REF}		1.5	-	3.6	V
I _{DD}	supply current	$VP > VM; T_{amb} = 25 °C; V_{DD} = 3.3 V$	[2]	-	90	-	μА
		$VM > VP; T_{amb} = 25 °C; V_{DD} = 3.3 V$	[2]	-	60	-	μА
V _{IC}	common-mode input voltage			0	-	V_{DD}	V
DVo	output voltage variation			0	-	V_{DD}	V
V _{offset}	offset voltage	V _{IC} = 0.1 V; V _{DD} = 3.0 V	[2]	-	4	-	mV
		V _{IC} = 1.5 V; V _{DD} = 3.0 V	[2]	-	6	-	mV
		V _{IC} = 2.9 V; V _{DD} = 3.0V	[2]	-	6	-	mV
Dynamic	characteristics				•		
t _{startup}	start-up time	nominal process; V _{DD} = 3.3 V; T _{amb} = 25 °C		-	13	-	μS

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Table 27. Comparator characteristics ...continued

 T_{amb} = -40 °C to +105 °C unless noted otherwise; V_{DD} = 1.71 V to 3.6 V.

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t _{PD}	propagation delay	HIGH to LOW; V_{DD} = 3.0 V; T_{amb} = 105 °C			320		
		V _{IC} = 0.1 V; 100 mV overdrive input	[1][2][4]	-		-	ns
		V _{IC} = 0.1 V; rail-to-rail input	[1][2]	-	260	-	ns
		V _{IC} = 1.5 V; 100 mV overdrive input	[1][2][4]	-	300	-	ns
		V _{IC} = 1.5 V; rail-to-rail input	[1][2]	-	160	-	ns
		V _{IC} = 2.9 V; 100 mV overdrive input	[1][2][4]	-	400	-	ns
		V _{IC} = 2.9 V; rail-to-rail input	[1][2]	-	80	-	ns
t _{PD}	propagation delay	LOW to HIGH; V_{DD} = 3.0 V; T_{amb} = 105 °C			170		
		V _{IC} = 0.1 V; 100 mV overdrive input	[1][2][4]	-		-	ns
		V _{IC} = 0.1 V; rail-to-rail input	[1][2]	-	80	-	ns
		V _{IC} = 1.5 V; 100 mV overdrive input	[1][2][4]	-	120	-	ns
		V _{IC} = 1.5 V; rail-to-rail input	[1][2]	-	220	-	ns
		V _{IC} = 2.9 V; 100 mV overdrive input	[1][2][4]	-	160	-	ns
		V _{IC} = 2.9 V; rail-to-rail input	[1][2]	-	320	-	ns
V_{hys}	hysteresis voltage	positive hysteresis; V_{DD} = 3.0 V; V_{IC} = 1.5 V; T_{amb} = 105 °C; settings:	[3]	-	6	-	
		5 mV					mV
		10 mV		-	11	-	mV
		20 mV		-	21	-	mV
V _{hys}	hysteresis voltage	negative hysteresis; $V_{DD} = 3.0 \text{ V}$; $V_{IC} = 1.5 \text{ V}$; $T_{amb} = 105 ^{\circ} \text{ C}$; settings:	[1][3]		11		
		5 mV		-		-	mV
		10 mV		-	18	-	mV
		20 mV		-	30	-	mV
R _{lad}	ladder resistance	-		_	1	_	ΜΩ

^[1] $C_L = 10 pF$

Table 28. Comparator voltage ladder dynamic characteristics

 $T_{amb} = -40 \, ^{\circ}\text{C} \text{ to } +105 \, ^{\circ}\text{C}; \ V_{DD} = 1.8 \, \text{V to } 3.6 \, \text{V}.$

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t _{s(pu)}	power-up settling time	to 99% of voltage ladder output value	<u>[1]</u>	-	17	-	μS
t _{s(sw)}	switching settling time	to 99% of voltage ladder output value	<u>[1]</u>	-	18	-	μS

^[1] Characterized on typical samples, not tested in production.

^[2] Characterized on typical samples, not tested in production.

^[3] Input hysteresis is relative to the reference input channel and is software programmable.

^{[4] 100} mV overdrive corresponds to a square wave from 50 mV below the reference (V_{IC}) to 50 mV above the reference.

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 Table 29.
 Comparator voltage ladder reference static characteristics

 V_{DD} = 1.8 V to 3.6 V. T_{amb} = -40 °C to + 105 °C; external or internal reference.

Symbol	Parameter	Conditions		Min	Typ[1]	Max	Unit
E _{V(O)}	output voltage error	decimal code = 00	[2]	-	±6	-	mV
		decimal code = 08		-	±1	-	%
		decimal code = 16		-	±1	-	%
		decimal code = 24		-	±1	-	%
		decimal code = 30		-	±1	-	%
		decimal code = 31		-	±1	-	%

^[1] Characterized though limited samples. Not tested in production.

^[2] All peripherals except comparator, temperature sensor, and FRO turned off.

15. Application information

15.1 Start-up behavior

<u>Figure 33</u> shows the start-up timing after reset. The FRO 12 MHz oscillator provides the default clock at Reset and provides a clean system clock shortly after the supply pins reach operating voltage.

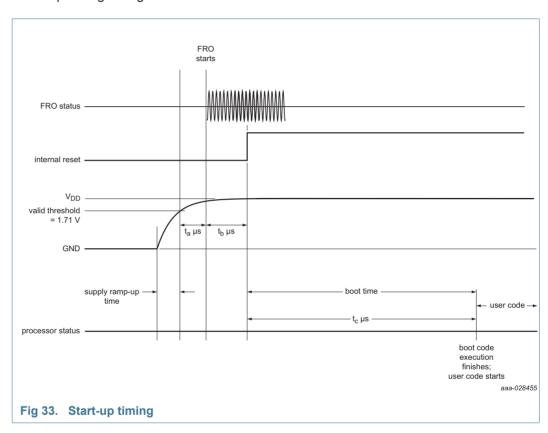
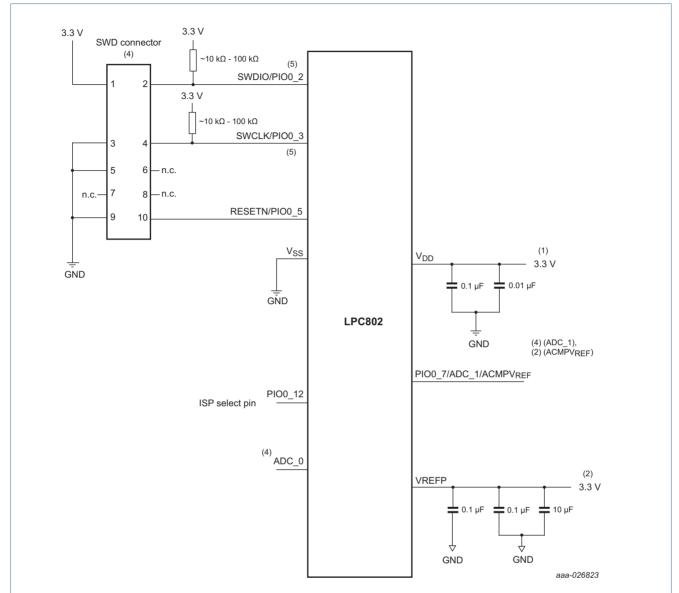


Table 30. Typical start-up timing parameters

Parameter	Description	Value
ta	FRO start time	≤ 26 μs
t _b	Internal reset de-asserted	101 μs
t _c	Boot time	36 μs

15.2 Connecting power, clocks, and debug functions

<u>Figure 34</u> shows the basic board connections used to power the LPC802 and provide debug capabilities via the serial wire port.



- (1) Position the decoupling capacitors of 0.1 μ F and 0.01 μ F as close as possible to the V_{DD} pin. Add one set of decoupling capacitors to each V_{DD} pin.
- (2) Position the decoupling capacitors of 0.1 μ F as close as possible to the VREFN and V_{DD} pins. The 10 μ F bypass capacitor filters the power line. Tie VREFP to V_{DD} if the ADC is not used. Tie VREFN to V_{SS} if ADC is not used.
- (3) Uses the ARM 10-pin interface for SWD.
- (4) When measuring signals of low frequency, use a low-pass filter to remove noise and to improve ADC performance. Also see Ref. 4.
- (5) External pull-up resistors on SWDIO and SWCLK pins are optional because these pins have an internal pull-up enabled by default.

Fig 34. Power, clock, and debug connections

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15.3 I/O power consumption

I/O pins are contributing to the overall dynamic and static power consumption of the part. If pins are configured as digital inputs, a static current can flow depending on the voltage level at the pin and the setting of the internal pull-up and pull-down resistors. This current can be calculated using the parameters R_{pu} and R_{pd} given in $\underline{\text{Table 14}}$ for a given input voltage $V_{I}.$ For pins set to output, the current drive strength is given by parameters I_{OH} and I_{OL} in $\underline{\text{Table 14}},$ but for calculating the total static current, you also need to consider any external loads connected to the pin.

I/O pins also contribute to the dynamic power consumption when the pins are switching because the V_{DD} supply provides the current to charge and discharge all internal and external capacitive loads connected to the pin in addition to powering the I/O circuitry.

The contribution from the I/O switching current I_{sw} can be calculated as follows for any given switching frequency f_{sw} if the external capacitive load (C_{ext}) is known (see <u>Table 14</u> for the internal I/O capacitance):

$$I_{sw} = V_{DD} x f_{sw} x (C_{io} + C_{ext})$$

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15.4 Termination of unused pins

<u>Table 31</u> shows how to terminate pins that are **not** used in the application. In many cases, unused pins may should be connected externally or configured correctly by software to minimize the overall power consumption of the part.

Unused pins with GPIO function should be configured as outputs set to LOW with their internal pull-up disabled. To configure a GPIO pin as output and drive it LOW, select the GPIO function in the IOCON register, select output in the GPIO DIR register, and write a 0 to the GPIO PORT register for that pin. Disable the pull-up in the pin's IOCON register.

In addition, it is recommended to configure all GPIO pins that are not bonded out on smaller packages as outputs driven LOW with their internal pull-up disabled.

Table 31. Termination of unused pins

Pin	Default state[1]	Recommended termination of unused pins
all PIOn_m	I; PU	Can be left unconnected if driven LOW and configured as GPIO output with pull-up disabled by software.
VREFP	-	Tie to VDD.

^[1] I = Input, O = Output, IA = Inactive (no pull-up/pull-down enabled), F = floating, PU = Pull-Up.

15.5 Pin states in different power modes

Table 32. Pin states in different power modes

Pin	Active	Sleep Deep-sleep/power- down		Deep power-down
PIOn_m pins	As configured in th enabled.	e IOCON[1]. Defau	ılt: internal pull-up	Floating.
RESET	Reset function ena enabled.	bled. Default: inpu	t, internal pull-up	Reset function disabled; floating; if the part is in deep power-down mode.

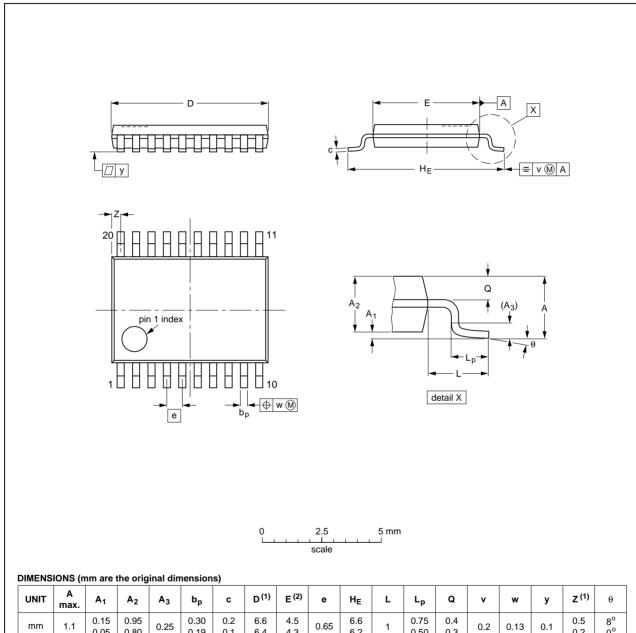
^[1] Default and programmed pin states are retained in sleep, deep-sleep, and power-down modes.

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16. Package outline

TSSOP20: plastic thin shrink small outline package; 20 leads; body width 4.4 mm

SOT360-1



UN	IIT	max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
m	m	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	6.6 6.4	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.5 0.2	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

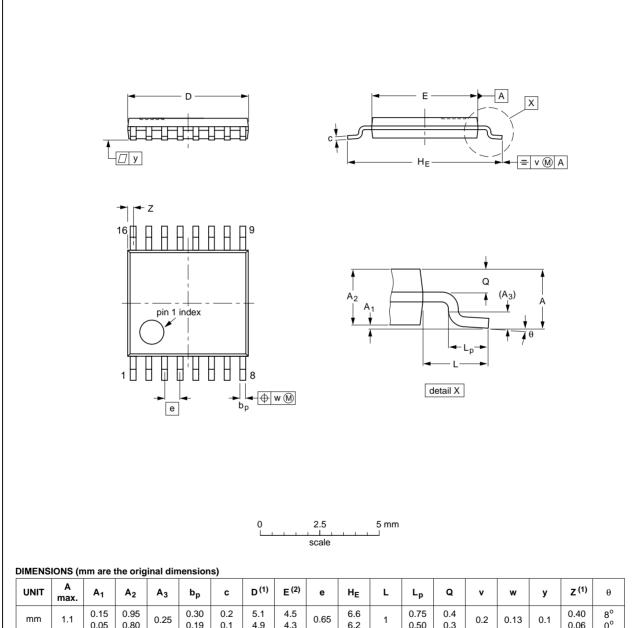
OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT360-1		MO-153			99-12-27 03-02-19

Fig 35. Package outline SOT360-1 (TSSOP20)

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TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1



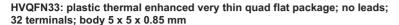
UNIT	A max.	A ₁	A ₂	A ₃	bp	С	D ⁽¹⁾	E ⁽²⁾	е	HE	L	Lp	Q	v	w	у	Z ⁽¹⁾	θ
mm	1.1	0.15 0.05	0.95 0.80	0.25	0.30 0.19	0.2 0.1	5.1 4.9	4.5 4.3	0.65	6.6 6.2	1	0.75 0.50	0.4 0.3	0.2	0.13	0.1	0.40 0.06	8° 0°

Notes

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT403-1		MO-153			99-12-27 03-02-18

Fig 36. Package outline SOT (TSSOP16)



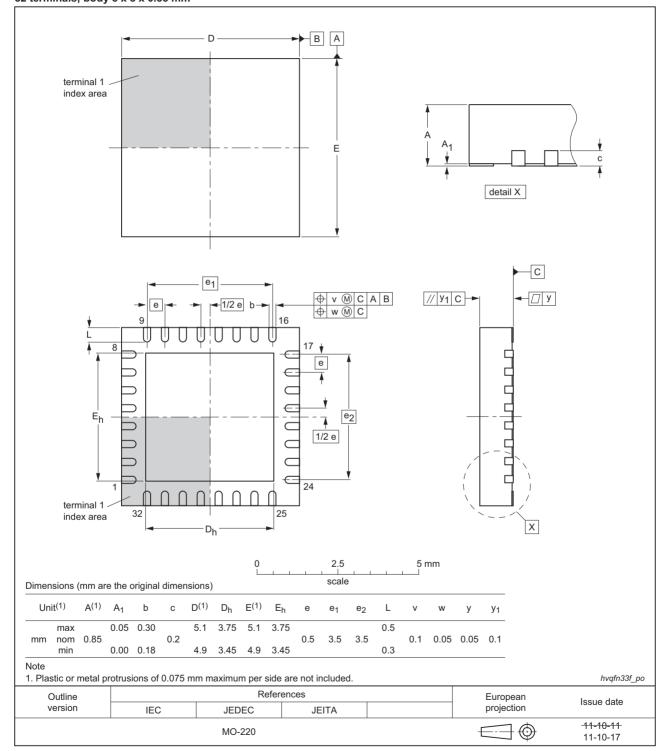
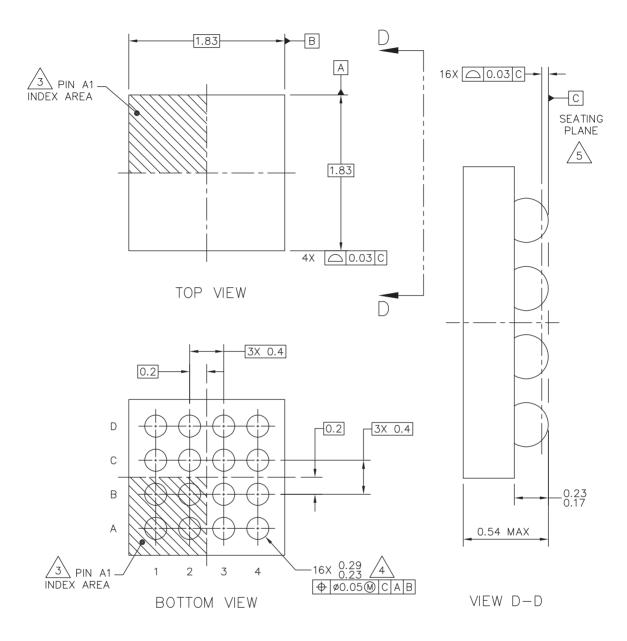


Fig 37. Package outline HVQFN33 (5 x 5 x 0.85 mm)



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MECHANICAL OUTLINE	STANDARD:	DRAWING NUMBER:	REVISION:	
PRINT VERSION NOT TO SCALE	NON JEDEC	SOT1393-2	0	

Fig 38. Package outline WLCSP16 (1.86 \times 1.86 \times 0.3 mm)

17. Soldering

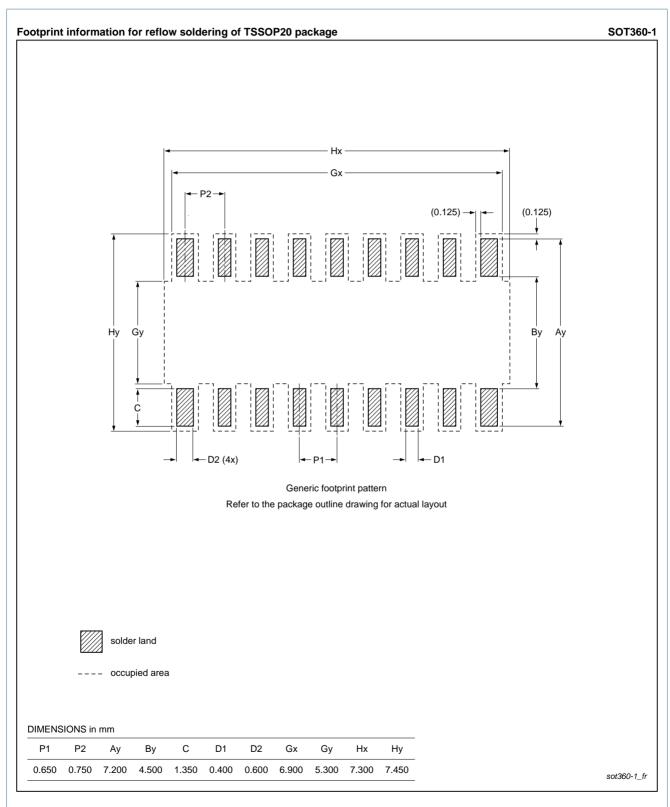


Fig 39. Reflow soldering of the TSSOP20 package

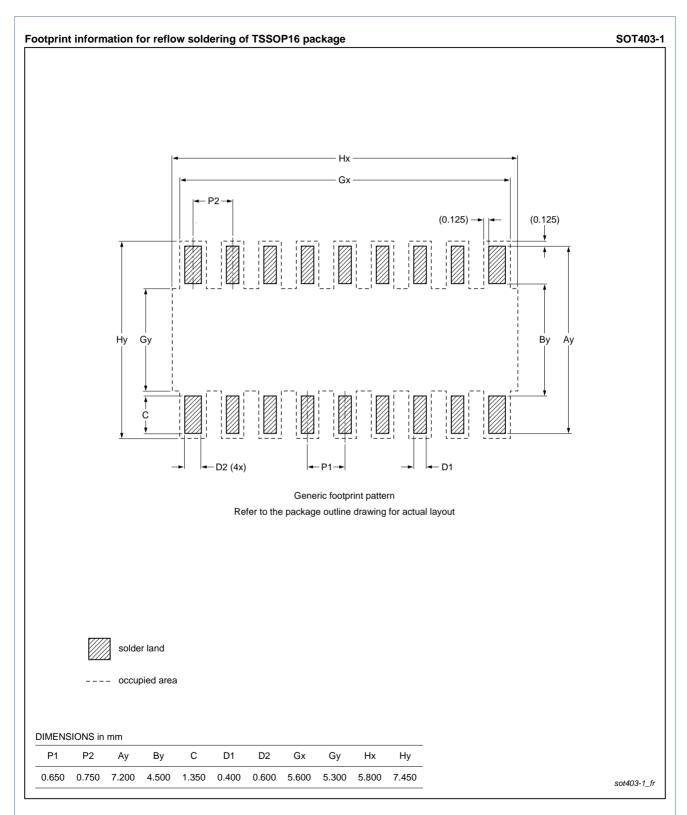


Fig 40. Reflow soldering of the TSSOP16 package

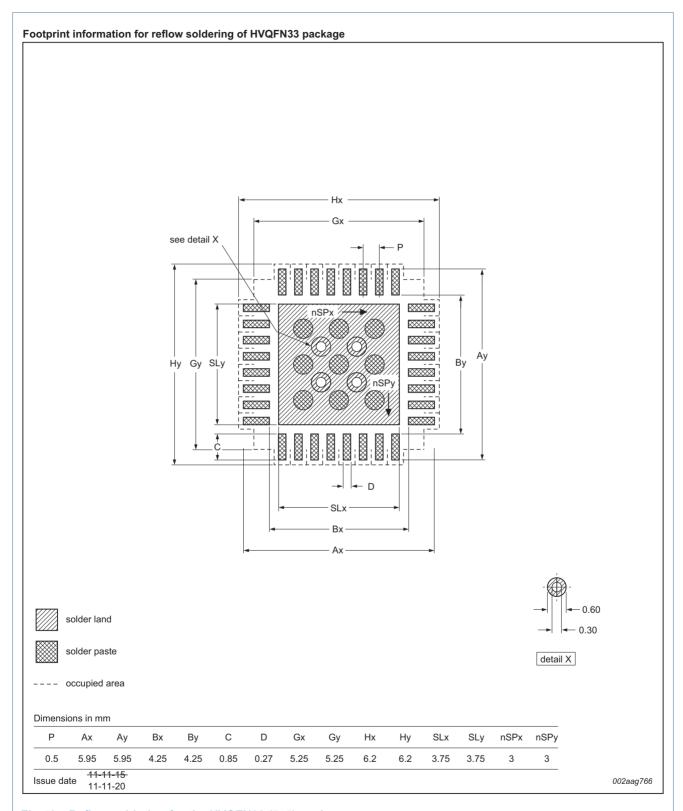
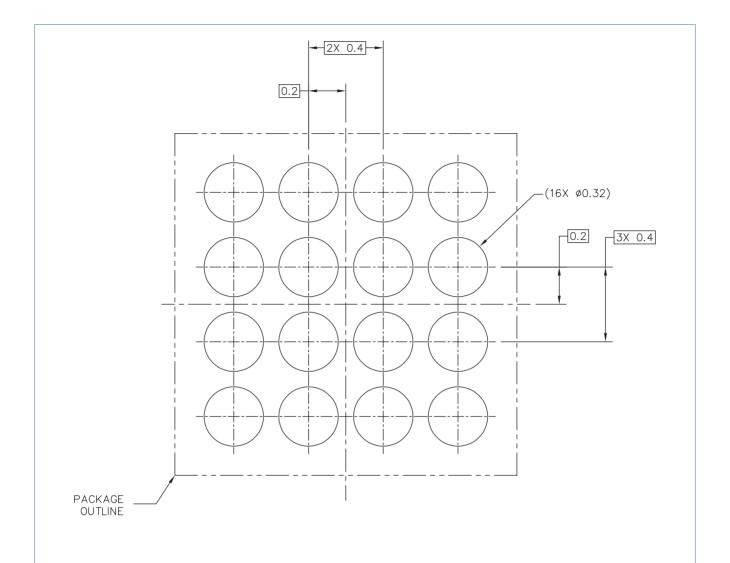


Fig 41. Reflow soldering for the HVQFN33 (5x5) package

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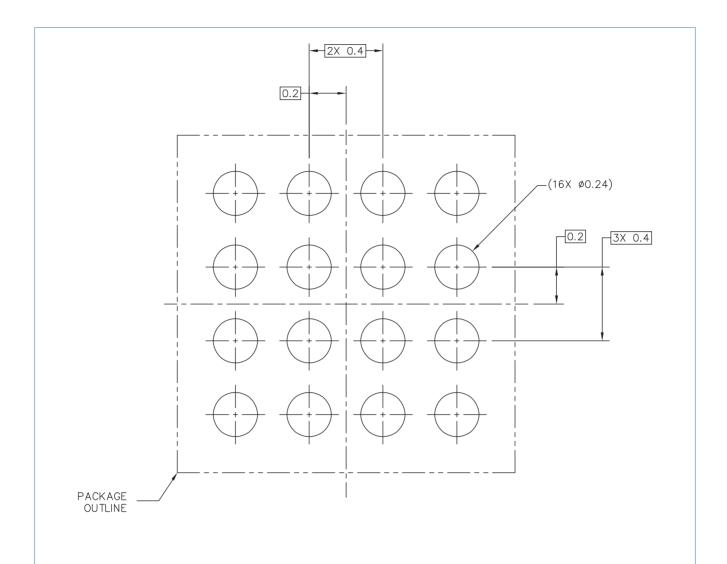
PCB DESIGN GUIDELINES - SOLDER MASK OPENING PATTERN

THIS SHEET SERVES ONLY AS A GUIDELINE TO HELP DEVELOP A USER SPECIFIC SOLUTION. DEVELOPMENT EFFORT WILL STILL BE REQUIRED BY END USERS TO OPTIMIZE PCB MOUNTING PROCESSES AND BOARD DESIGN IN ORDER TO MEET INDIVIDUAL/SPECIFIC REQUIREMENTS.

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Fig 42. Reflow soldering for the WLCSP16 (4x4) package (1 of 3)

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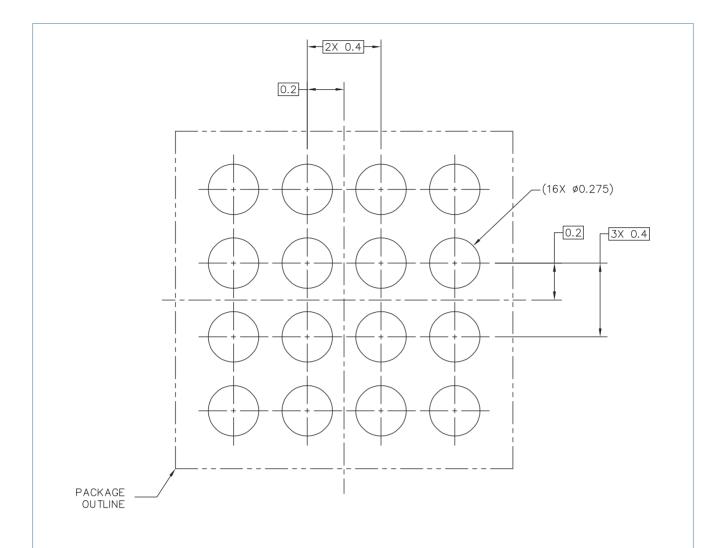
PCB DESIGN GUIDELINES - I/O PADS AND SOLDERABLE AREA

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MECHANICAL OUTLINE	STANDARD:	DRAWING NUMBER:	REVISION:	
PRINT VERSION NOT TO SCALE	NON JEDEC	SOT1393-2	0	

Fig 43. Reflow soldering for the WLCSP16 (4x4) package (2 of 3)

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RECOMMENDED STENCIL THICKNESS 0.1

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Fig 44. Reflow soldering for the WLCSP16 (4x4) package (3 of 3)

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18. Abbreviations

Table 33. Abbreviations

Acronym	Description			
AHB	Advanced High-performance Bus			
APB	Advanced Peripheral Bus			
BOD	BrownOut Detection			
GPIO	General-Purpose Input/Output			
RC	Resistor-Capacitor			
SPI	Serial Peripheral Interface			
SMBus	System Management Bus			
TEM	Transverse ElectroMagnetic			
UART	Universal Asynchronous Receiver/Transmitter			

19. References

- [1] LPC802 User manual UM11045.
- [2] LPC802 Errata sheet.
- [3] I2C-bus specification UM10204.
- [4] Technical note ADC design guidelines: http://www.nxp.com/documents/technical_note/TN00009.pdf

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20. Revision history

Table 34. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
LPC802 v.1.8	20190917	Product data sheet	-	LPC802 v.1.7
Modifications:	Added dev	ice revision 1D.		
LPC802 v.1.7	20190917	Product data sheet	-	LPC802 v.1.6
Modifications:	Updated delight	evice revision.		
LPC802 v.1.6	20180427	Product data sheet	-	LPC802 v.1.5
Modifications:	registers a	to Section 9.22.4.4 "Decre available to store info	rmation during dee	
	Updated S	ection 9.22.1 "Internal of ection 15.2 "Connecting e external crystal.		d neading title. debug functions": removed text:
LPC802 v.1.5	20180312	Product data sheet	-	LPC802 v.1.4
Modifications:	Updated Ta	able 3 "Device revision to	able".	
LPC802 v.1.4	20180227	Product data sheet	-	LPC802 v.1.3
Modifications:	Added Figu	ure 38 "Package outline	WLCSP16 (1.86 '1	.86 ′ 0.3 mm)".
	43 "Reflow soldering for Updated tit Updated Tage 1 MHz, V Updated Tage 2 Updated Tage 3 MHz, V	soldering for the WLCS or the WLCSP16 (4x4) purely of Section 13.1 "Flash able 12 "Static character (DD = 3.3 V. Able 16 "Dynamic character character (Apple 16 "Dynamic character charac	P16 (4x4) package ackage (3 of 3)". memory (EEPRO istics, supply pins":	(4x4) package (1 of 3)", Figure (2 of 3)", and Figure 44 "Reflow M based)". Added condition: system clock values: FRO clock frequency; uency; Condition: -40 °C ≤ T _{amb}
LPC802 v.1.3	20180209	Product data sheet	-	LPC802 v.1.2
Modifications:	 Updated Ta PIO0_17 th Added leve Updated Ta 	nrough switch matrix)". I shifter functionality to sable 16 "Dynamic character IS MHz. Added Conditio	s (assign to pins P Section 9.8 "I/O con steristic: FRO": Cha	IO0_0 to PIO0_5, PIO0_7 to infiguration". anged frequencies to 9 MHz, 12 ≤ 70 °C and Condition: –40 °C ≤
LPC802 v.1.2	20171222	Product data sheet	-	LPC802 v.1.1
Modifications:	Updated FUpdated Ta	igure 4 "LPC802 block digure 12 "LPC802 clock dable 7 "Peripheral configuis on standby.	generation".	power modes": In deep-sleep
LPC802 v.1.1	20171222	Product data sheet	-	LPC802 v.1
Modifications:		igure 21 "High-drive outp		evel output voltage VOH versus

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21. Legal information

21.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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